## SIEMENS

## Microcomputer Components

8-Bit CMOS Microcontroller

## C515C

Data Sheet 12.97

| C515C Data Sheet Revision History : |  | Version: 12.97 |
| :---: | :---: | :---: |
| Previous Versions : |  | 07.97, 09.96 |
| Page (in previous version) | Page (in current version) | Subjects (major changes since last revision) |
| general |  | C515C-8E OTP version included; |
| 15, 20 <br> 24-28 <br> 52, 54 <br> several | $\begin{array}{\|l} \hline 4 \\ 17,22 \\ 25-30 \\ \\ \\ \text { several } \end{array}$ | Short description of the two new features of the C515C-8E Correction and extension of the SYSCON register description Table 3 to 5: corrections for PCON1, IEN0, SYSCON, P4, P7, and DB0n to DB7n registers <br> More exact description of the overload current conditions. Replacing $V_{\mathrm{CC}}$ and $I_{\mathrm{CC}}$ by $V_{\mathrm{DD}}$ and $I_{\mathrm{DD}}$ |
|  |  | Subjects (major changes from revision 09.96 to revision 07.97 |
| $\begin{aligned} & \hline 4 \\ & 19 \\ & 52,53 \\ & 56,57 \\ & 62 \end{aligned}$ | $\begin{array}{\|l\|} \hline 4 \\ 19 \\ 52,53 \\ 56,57 \\ 62 \end{array}$ | SSC transfer rate at $10 \mathrm{MHz}=2.5 \mathrm{MHz}$ <br> Figure reference corrected <br> Power sav. modes : description of hardware power down mode added Icc specification has been extended tsCLK for Master Mode corrected |

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## SIEMENS

## 8-Bit CMOS Microcontroller

C515C

## Advance Information

- Full upward compatibility with SAB 80C515A
- On-chip program memory (with optional memory protection)
- C515C-8R : 64k byte on-chip ROM
- C515C-8E : 64k byte on-chip OTP
- alternatively up to 64 k byte external program memory
- 256 byte on-chip RAM
- 2K byte of on-chip XRAM
- Up to 64 K byte external data memory
- Superset of the 8051 architecture with 8 datapointers
- Up to 10 MHz external operating frequency ( $1 \mu \mathrm{~s}$ instruction cycle time at 6 MHz external clock)
- On-chip emulation support logic (Enhanced Hooks Technology ${ }^{\top M}$ )
- Current optimized oscillator circuit and EMI optimized design
- Eight ports : 48+1 digital I/O lines, 8 analog inputs
- Quasi-bidirectional port structure (8051 compatible)
- Port 5 selectable for bidirectional port structure (CMOS voltage levels)
- Full-CAN controller on-chip
- 256 register/data bytes are located in external data memory area
- max. 1 MBaud at $8-10 \mathrm{MHz}$ operating frequency
(further features are on next page)


Figure 1
C515C Functional Units
Enhanced Hooks Technology ${ }^{\text {TM }}$ is a trademark of Siemens AG.

Features (cont'd):

- Three 16-bit timer/counters
- Timer 2 can be used for compare/capture functions
- 10-bit A/D converter with multiplexed inputs and built-in self calibration
- Full duplex serial interface with programmable baudrate generator (USART)
- SSC synchronous serial interface (SPI compatible)
- Master and slave capable
- Programmable clock polarity / clock-edge to data phase relation
- LSB/MSB first selectable
- 2.5 MHz transfer rate at 10 MHz operating frequency
- Seventeen interrupt vectors, at four priority levels selectable
- Extended watchdog facilities
- 15-bit programmable watchdog timer
- Oscillator watchdog
- Power saving modes
- Slow-down mode
- Idle mode (can be combined with slow-down mode)
- Software power-down mode with wake-up capability through $\overline{\mathrm{NTO}}$ or RXDC pin
- Hardware power-down mode
- CPU running condition output pin
- ALE can be switched off
- Multiple separate VDD/VSS pin pairs
- P-MQFP-80-1 package
- Temperature Ranges: SAB-C515C-8R $T_{\mathrm{A}}=0$ to $70^{\circ} \mathrm{C}$

SAF-C515C-8R $\quad T_{\mathrm{A}}=-40$ to $85^{\circ} \mathrm{C}$
SAH-C515C-8R $\quad T_{A}=-40$ to $110^{\circ} \mathrm{C}$
The C515C is an enhanced, upgraded version of the SAB 80C515A 8-bit microcontroller which additionally provides a full CAN interface, a SPI compatible synchronous serial interface, extended power save provisions, additional on-chip RAM, 64K of on-chip program memory, two new external interrupts and RFI related improvements. With a maximum external clock rate of 10 MHz it achieves a 600 ns instruction cycle time ( $1 \mu \mathrm{~s}$ at 6 MHz ).

The C515C-8R contains a non-volatile 64k byte read-only program memory. The C515C-L is identical to the C515C-8R, except that it lacks the on-chip program memory The C515C-8E is the OTP version in the C515C microcontroller with an on-chip 64 k byte one-time programmable (OTP) program memory. The C515C is mounted in a P-MQFP-80 package.
If compared to the C515C-8R and C515C-L, the C515C-8E OTP version additionally provides two features:

- the wake-up from software power down mode can, additionally to the external pin P3.2/I/NT0 wake-up capability, also be triggered alternatively by a second pin P4.7/RXDC.
- for power consumption reasons the on-chip CAN controller can be switched off.

Note: Versions for extended temperature ranges $-40^{\circ} \mathrm{C}$ to $110^{\circ} \mathrm{C}$ (SAH-C515C-LM and SAH-C515C-8RM) are available on request. The ordering number of ROM types (DXXXX extensions) is defined after program release (verification) of the customer.

## Ordering Information

| Type | Ordering Code | Package | Description <br> (8-Bit CMOS microcontroller) |
| :--- | :--- | :--- | :--- |
| SAB-C515C-LM | Q67121-C1066 | P-MQFP-80-1 | for external memory (10 MHz) |
| SAF-C515C-LM | Q67121-C1058 | P-MQFP-80-1 | for external memory $(10 \mathrm{MHz})$ <br> ext. temp. $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ |
| SAB-C515C-8RM | Q67121-DXXXX | P-MQFP-80-1 | with mask programmable ROM (10 MHz) |
| SAF-C515C-8RM | Q67121-DXXXX | P-MQFP-80-1 | with mask programmable ROM (10 MHz) <br> ext. temp. $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ |
| SAB-C515C-8EM | Q67121-C1057 | P-MQFP-80-1 | with OTP memory (10 MHz) |
| SAF-C515C-8EM | Q67121-C2083 | P-MQFP-80-1 | with OTP memory $(10 \mathrm{MHz})$ <br> ext. temp. $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$ |



Figure 2

## Logic Symbol



Figure 3

## C515C Pin Configuration (P-MQFP-80-1, Top View)

Table 1
Pin Definitions and Functions

| Symbol | Pin Number | I/O*) | Function |
| :--- | :--- | :--- | :--- |
|  | P-MQFP-80 |  |  |
| RESET | 1 | I | RESET <br> A low level on this pin for the duration of two machine <br> cycles while the oscillator is running resets the C515C. A <br> small internal pullup resistor permits power-on reset <br> using only a capacitor connected to VSS. |
| VAREF | 3 | - | Reference voltage for the A/D converter |
| VAGND | 4 | - | Reference ground for the A/D converter |
| P6.0-P6.7 | $12-5$ | I | Port 6 <br> is an 8-bit unidirectional input port to the A/D converter. <br> Port pins can be used for digital input, if voltage levels <br> simultaneously meet the specifications high/low input <br> voltages and for the eight multiplexed analog inputs. |

Table 1
Pin Definitions and Functions (cont'd)

| Symbol | Pin Number | I/O*) | Function |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  | P-MQFP-80 |  |  |  |  |
| P3.0-P3.7 | 15-22 | I/O | Port 3 <br> is an 8-bit quasi-bidirectional I/O port with internal pullup resistors. Port 3 pins that have 1's written to them are pulled high by the internal pullup resistors, and in that state can be used as inputs. As inputs, port 3 pins being externally pulled low will source current ( $I_{\mathrm{LL}}$, in the DC characteristics) because of the internal pullup resistors. Port 3 also contains the interrupt, timer, serial port and external memory strobe pins that are used by various options. The output latch corresponding to a secondary function must be programmed to a one (1) for that function to operate. The secondary functions are assigned to the pins of port 3 , as follows: |  |  |
|  | 15 |  | P3.0 | RXD | Receiver data input (asynch.) or data input/output (synch.) of serial interface |
|  | 16 |  | P3.1 | TXD | Transmitter data output (asynch.) or clock output (synch.) of serial interface |
|  | 17 |  | P3.2 | $\overline{\text { INTO }}$ | External interrupt 0 input / timer 0 gate control input |
|  | 18 |  | P3.3 | $\overline{\text { INT1 }}$ | External interrupt 1 input / timer 1 gate control input |
|  | 19 |  | P3.4 | T0 | Timer 0 counter input |
|  | 20 |  | P3.5 | T1 | Timer 1 counter input |
|  | 21 |  | P3.6 | $\overline{W R}$ | $\overline{W R}$ control output; latches the data byte from port 0 into the external data memory |
|  | 22 |  | P3.7 | $\overline{\mathrm{RD}}$ | $\overline{\mathrm{RD}}$ control output; enables the external data memory |

[^0]Table 1
Pin Definitions and Functions (cont'd)

| Symbol | Pin Number | I/O*) | Function |
| :---: | :---: | :---: | :---: |
|  | P-MQFP-80 |  |  |
| P7.0 / INT7 | 23 | I/O | Port 7 <br> is an 1-bit quasi-bidirectional I/O port with internal pull-up resistor. When a 1 is written to P 7.0 it is pulled high by an internal pull-up resistor, and in that state can be used as input. As input, P7.0 being externally pulled low will source current ( $I_{\mathrm{LL}}$, in the DC characteristics) because of the internal pull-up resistor. If P7.0 is used as interrupt input, its output latch must be programmed to a one (1). The secondary function is assigned to the port 7 pin as follows: <br> P7.0 $\overline{\text { INT7 }}$ Interrupt 7 input |
| P1.0-P1.7 | 31-24 | I/O | Port 1 <br> is an 8-bit quasi-bidirectional I/O port with internal pullup resistors. Port 1 pins that have 1's written to them are pulled high by the internal pullup resistors, and in that state can be used as inputs. As inputs, port 1 pins being externally pulled low will source current ( $I_{\mathrm{LL}}$, in the DC characteristics) because of the internal pullup resistors. The port is used for the low-order address byte during program verification. Port 1 also contains the interrupt, timer, clock, capture and compare pins that are used by various options. The output latch corresponding to a secondary function must be programmed to a one (1) for that function to operate (except when used for the compare functions). The secondary functions are assigned to the port 1 pins as follows: |
|  | 31 |  | P1.0 INT3 CC0 Interrupt 3 input/compare 0 output/ capture 0 input |
|  | 30 |  | P1.1 INT4 CC1 Interrupt 4 input/ compare 1 output/ capture 1 input |
|  | 29 |  | P1.2 INT5 CC2 Interrupt 5 input/ compare 2 output / capture 2 input |
|  | 28 |  | P1.3 INT6 CC3 Interrupt 6 input/compare 3 output/ capture 3 input |
|  | 27 |  | P1.4 $\overline{\mathrm{NT} 2}$ Interrupt 2 input |
|  | 26 |  | $\begin{array}{ll}\text { P1.5 T2EX } & \begin{array}{l}\text { Timer } 2 \text { external reload / trigger } \\ \text { input }\end{array}\end{array}$ |
|  | 25 24 |  | P1.6 CLKOUT System clock output <br> P1.7 T2 Counter 2 input |

[^1]Table 1
Pin Definitions and Functions (cont'd)

| Symbol | Pin Number | I/O*) | Function |
| :---: | :---: | :---: | :---: |
|  | P-MQFP-80 |  |  |
| XTAL2 | 36 | I | XTAL2 <br> Input to the inverting oscillator amplifier and input to the internal clock generator circuits. <br> To drive the device from an external clock source, XTAL2 should be driven, while XTAL1 is left unconnected. Minimum and maximum high and low times as well as rise/fall times specified in the AC characteristics must be observed. |
| XTAL1 | 37 | 0 | XTAL1 <br> Output of the inverting oscillator amplifier. |
| P2.0-P2.7 | 38-45 | I/O | Port 2 <br> is an 8-bit quasi-bidirectional I/O port with internal pullup resistors. Port 2 pins that have 1 's written to them are pulled high by the internal pullup resistors, and in that state can be used as inputs. As inputs, port 2 pins being externally pulled low will source current ( $I_{\mathrm{IL}}$, in the DC characteristics) because of the internal pullup resistors. Port 2 emits the high-order address byte during fetches from external program memory and during accesses to external data memory that use 16-bit addresses (MOVX @DPTR). In this application it uses strong internal pullup resistors when issuing 1 's. During accesses to external data memory that use 8-bit addresses (MOVX @Ri), port 2 issues the contents of the P2 special function register. |
| $\overline{\text { CPUR }}$ | 46 | 0 | CPU running condition <br> This output pin is at low level when the CPU is running and program fetches or data accesses in the external data memory area are executed. In idle mode, hardware and software power down mode, and with an active $\overline{\text { RESET }}$ signal $\overline{\text { CPUR }}$ is set to high level. $\overline{\mathrm{CPUR}}$ can be typically used for switching external memory devices into power saving modes. |

*) I = Input
$\mathrm{O}=$ Output

Table 1
Pin Definitions and Functions (cont'd)

| Symbol | Pin Number | 1/0*) | Function |
| :---: | :---: | :---: | :---: |
|  | P-MQFP-80 |  |  |
| $\overline{\text { PSEN }}$ | 47 | 0 | The Program Store Enable output is a control signal that enables the external program memory to the bus during external fetch operations. It is activated every six oscillator periods, except during external data memory accesses. The signal remains high during internal program execution. |
| ALE | 48 | 0 | The Address Latch enable output is used for latching the address into external memory during normal operation. It is activated every six oscillator periods, except during an external data memory access. ALE can be switched off when the program is executed internally. |
| $\overline{E A}$ | 49 | I | External Access Enable <br> When held high, the C515C executes instructions always from the internal ROM. When held low, the C515C fetches all instructions from external program memory. |
| P0.0-P0.7 | 52-59 | I/O | Port 0 <br> is an 8-bit open-drain bidirectional I/O port. <br> Port 0 pins that have 1 's written to them float, and in that state can be used as high-impedance inputs. <br> Port 0 is also the multiplexed low-order address and data bus during accesses to external program and data memory. In this application it uses strong internal pullup resistors when issuing 1's. <br> Port 0 also outputs the code bytes during program verification in the C515C. External pullup resistors are required during program verification. |
| P5.0-P5.7 | 67-60 | I/O | Port 5 <br> is an 8-bit quasi-bidirectional I/O port with internal pullup resistors. Port 5 pins that have 1's written to them are pulled high by the internal pullup resistors, and in that state can be used as inputs. As inputs, port 5 pins being externally pulled low will source current ( $I_{\mathrm{LL}}$, in the DC characteristics) because of the internal pullup resistors. Port 5 can also be switched into a bidirectional mode, in which CMOS levels are provided. In this bidirectional mode, each port 5 pin can be programmed individually as input or output. |

[^2]Table 1
Pin Definitions and Functions (cont'd)

| Symbol | Pin Number | I/O*) | Function |
| :---: | :---: | :---: | :---: |
|  | P-MQFP-80 |  |  |
| $\overline{\text { HWPD }}$ | 69 | I | Hardware Power Down <br> A low level on this pin for the duration of one machine cycle while the oscillator is running resets the C515C. A low level for a longer period will force the part to power down mode with the pins floating. |
| P4.0-P4.7 | $\begin{array}{\|l} 72-74,76-80 \\ \\ \\ \\ \\ \\ \\ \\ \\ 72 \\ 73 \\ 74 \\ 76 \\ 77 \\ 78 \\ 79 \\ 80 \end{array}$ | I/O | Port 4 <br> is an 8-bit quasi-bidirectional I/O port with internal pull-up resistors. Port 4 pins that have 1's written to them are pulled high by the internal pull-up resistors, and in that state can be used as inputs. As inputs, port 4 pins being externally pulled low will source current ( $I_{\mathrm{IL}}$, in the DC characteristics) because of the internal pull-up resistors. P4 also contains the external A/D converter control pin, the SSC pins, the CAN controller input/output lines, and the external interrupt 8 input. The output latch corresponding to a secondary functionmust be programmed to a one (1) for that function to operate. The alternate functions are assigned to port 4 as follows: P4.0 ADST External A/D converter start pin <br> P4.1 SCLK SSC Master Clock Output / <br> SSC Slave Clock Input <br> P4.2 SRI <br> SSC Receive Input <br> P4.3 STO SSC Transmit Output <br> P4.4 SLS Slave Select Input <br> P4.5 INT8 External interrupt 8 input <br> P4.6 TXDC Transmitter output of the CAN controller <br> P4.7 RXDC Receiver input of the CAN controller |
| $\overline{\text { PE/SWD }}$ | 75 | 1 | Power saving mode enable / Start watchdog timer A low level on this pin allows the software to enter the power down, idle and slow down mode. In case the low level is also seen during reset, the watchdog timer function is off on default. <br> Use of the software controlled power saving modes is blocked, when this pin is held on high level. A high level during reset performs an automatic start of the watchdog timer immediately after reset. When left unconnected this pin is pulled high by a weak internal pull-up resistor. |

[^3]Table 1
Pin Definitions and Functions (cont'd)

| Symbol | Pin Number | 1/0*) | Function |
| :---: | :---: | :---: | :---: |
|  | P-MQFP-80 |  |  |
| VSSCLK | 13 | - | Ground ( 0 V ) for on-chip oscillator <br> This pin is used for ground connection of the on-chip oscillator circuit. |
| VDDCLK | 14 | - | Supply voltage for on-chip oscillator This pin is used for power supply of the on-chip oscillator circuit. |
| VDDE1 <br> VDDE2 | $\begin{aligned} & 32 \\ & 68 \end{aligned}$ | - | Supply voltage for I/O ports <br> These pins are used for power supply of the I/O ports during normal, idle, and power-down mode. |
| $\begin{aligned} & \hline \text { VSSE1 } \\ & \text { VSSE2 } \end{aligned}$ | $\begin{aligned} & 35 \\ & 70 \end{aligned}$ | - | Ground ( 0 V ) for I/O ports <br> These pins are used for ground connections of the I/O ports during normal, idle, and power-down mode. |
| VDD1 | 33 | - | Supply voltage for internal logic <br> This pins is used for the power supply of the internal logic circuits during normal, idle, and power down mode. |
| VSS1 | 34 | - | Ground ( 0 V ) for internal logic <br> This pin is used for the ground connection of the internal logic circuits during normal, idle, and power down mode. |
| VDDEXT | 50 | - | Supply voltage for external access pins <br> This pin is used for power supply of the I/O ports and control signals which are used during external accesses (for Port 0, Port 2, ALE, $\overline{\text { PSEN, P3.6/WR, and P3.7/RD). }}$ |
| VSSEXT | 51 | - | Ground ( 0 V ) for external access pins <br> This pin is used for the ground connection of the I/O ports and control signals which are used during external accesses (for Port 0, Port 2, ALE, PSEN, P3.6/(̄RR, and P3.7/RD). |
| N.C. | 2, 71 | - | Not connected <br> These pins should not be connected. |

*) I = Input
$\mathrm{O}=$ Output


Figure 4
Block Diagram of the C515C

## CPU

The C515C is efficient both as a controller and as an arithmetic processor. It has extensive facilities for binary and BCD arithmetic and excels in its bit-handling capabilities. Efficient use of program memory results from an instruction set consisting of $44 \%$ one-byte, $41 \%$ two-byte, and $15 \%$ threebyte instructions. With a 6 MHz crystal, $58 \%$ of the instructions are executed in $1 \mu \mathrm{~s}(10 \mathrm{MHz}$ : 600 ns ).

Special Function Register PSW (Address $\mathrm{DO}_{\mathrm{H}}$ )
Reset Value : $\mathbf{0 0}_{\mathbf{H}}$

Bit No. MSB LSB


| Bit | Function |  |  |
| :---: | :---: | :---: | :---: |
| CY | Carry Flag <br> Used by arithmetic instruction. |  |  |
| AC | Auxiliary Carry Flag <br> Used by instructions which execute BCD operations. |  |  |
| F0 | General Purpose Flag |  |  |
| $\begin{aligned} & \hline \text { RS1 } \\ & \text { RS0 } \end{aligned}$ | Register Bank select control bits These bits are used to select one of the four register banks. |  |  |
|  | RS1 | RS0 | Function |
|  | 0 | 0 | Bank 0 selected, data address $00{ }_{H}{ }^{-07} \mathrm{H}$ |
|  | 0 | 1 | Bank 1 selected, data address $08{ }^{-}{ }^{-0 F_{H}}$ |
|  | 1 | 0 | Bank 2 selected, data address $10 \mathrm{H}^{-17} \mathrm{H}$ |
|  | 1 | 1 | Bank 3 selected, data address $18 \mathrm{H}^{-1 \mathrm{~F}_{\mathrm{H}}}$ |
| OV | Overflow Flag <br> Used by arithmetic instruction. |  |  |
| F1 | General Purpose Flag |  |  |
| P | Parity Flag <br> Set/cleared by hardware after each instruction to indicate an odd/even number of "one" bits in the accumulator, i.e. even parity. |  |  |

## Memory Organization

The C515C CPU manipulates data and operands in the following five address spaces:

- up to 64 Kbyte of internal/external program memory
- up to 64 Kbyte of external data memory
- 256 bytes of internal data memory
- 256 bytes CAN controller registers / data memory
- 2K bytes of internal XRAM data memory
- a 128 byte special function register area

Figure 5 illustrates the memory address spaces of the C515C.


Figure 5 C515C Memory Map

## Control of XRAM/CAN Controller Access

The XRAM in the C515C is a memory area that is logically located at the upper end of the external memory space, but is integrated on the chip. Because the XRAM and the CAN controller is used in the same way as external data memory the same instruction types (MOVX) must be used for accessing the XRAM. Two bits in SFR SYSCON, XMAPO and XMAP1, control the accesses to the XRAM and the CAN controller.

Special Function Register SYSCON (Address B1H) Reset Value C515C-8R : X010XX01B Reset Value C515C-8E : X010X001B

| Bit No. | MSB |  |  |  |  |  |  | LSB |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |  |
| ${ }^{B 1} H^{\prime}$ | - | PMOD | EALE | RMAP | - | CSWO | XMAP1 | XMAP0 | SYSCON |

The function of the shaded bits is not described in this section.

| Bit | Function |
| :---: | :---: |
| XMAP1 | XRAM/CAN controller visible access control <br> Control bit for $\overline{R D} / \overline{W R}$ signals during XRAM/CAN Controller accesses. If addresses are outside the XRAM/CAN controller address range or if XRAM is disabled, this bit has no effect. <br> XMAP1 $=0$ : The signals $\overline{\mathrm{RD}}$ and $\overline{\mathrm{WR}}$ are not activated during accesses to the XRAM/CAN Controller <br> XMAP1 $=1:$ Ports 0,2 and the signals $\overline{\mathrm{RD}}$ and $\overline{\mathrm{WR}}$ are activated during accesses to XRAM/CAN Controller. In this mode, address and data information during XRAM/CAN Controller accesses are visible externally. |
| XMAPO | Global XRAM/CAN controller access enable/disable control <br> XMAPO $=0$ : The access to XRAM and CAN controller is enabled. <br> XMAPO $=1:$ The access to XRAM and CAN controller is disabled (default after reset). All MOVX accesses are performed via the external bus. Further, this bit is hardware protected. |

Bit XMAPO is hardware protected. If it is reset once (XRAM/CAN controller access enabled) it cannot be set by software. Only a reset operation will set the XMAP0 bit again.

The XRAM/CAN controller can be accessed by read/write instructions (MOVX A,DPTR, MOVX @DPTR,A), which use the 16-bit DPTR for indirect addressing. For accessing the XRAM or CAN controller, the effective address stored in DPTR must be in the range of $\mathrm{F7OO}_{\mathrm{H}}$ to $\mathrm{FFFF}_{\mathrm{H}}$.

The XRAM can be also accessed by read/write instructions (MOVX A,@Ri, MOVX @Ri,A), which use only an 8-bit address (indirect addressing with registers R0 or R1). Therefore, a special page register XPAGE which provides the upper address information (A8-A15) during 8-bit XRAM accesses. The behaviour of Port 0 and P2 during a MOVX access depends on the control bits XMAPO and XMAP1 in register SYSCON and on the state of pin EA. Table 2 lists the various operating conditions.

|  |  | $\overline{E A}=0$ |  |  | $\overline{E A}=1$ |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | XMAP1, XMAP0 |  |  | XMAP1, XMAP0 |  |  |
|  |  | 00 | 10 | X1 | 00 | 10 | X1 |
| MOVX @DPTR | DPTR <br> < <br> XRAM/CAN <br> address <br> range | a) $\mathrm{P} 0 / \mathrm{P} 2 \rightarrow$ Bus <br> b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active c)ext.memory is used | a) $\mathrm{PO} / \mathrm{P} 2 \rightarrow$ Bus b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active c)ext.memory is used | a) $\mathrm{PO} 0 / \mathrm{P} 2 \rightarrow$ Bus <br> b) $\overline{R D} / \overline{W R}$ active c)ext.memory is used | a)P0/P2 $\rightarrow$ Bus b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active c)ext.memory is used | a) $\mathrm{P} 0 / \mathrm{P} 2 \rightarrow \mathrm{Bus}$ b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active c)ext.memory is used | a) $\mathrm{P} 0 / \mathrm{P} 2 \rightarrow \mathrm{Bus}$ b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active c)ext.memory is used |
|  | DPTR <br> $\geq$ <br> XRAMCAN <br> address <br> range | a) P0/P2 $\rightarrow$ Bus ( $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$-Data) b) $\overline{R D} / \overline{W R}$ inactive c) XRAM is used | a)P0/P2 $\rightarrow$ Bus <br> ( $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$-Data) <br> b) $\overline{R D} / \overline{W R}$ active <br> c)XRAM is used | a) $\mathrm{P} 0 / \mathrm{P} 2 \rightarrow \mathrm{Bus}$ <br> b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active <br> c) ext.memory is used | a) $\mathrm{PO} / \mathrm{P} 2 \rightarrow \mathrm{I} / 0$ <br> b) $\overline{R D} / \overline{W R}$ inactive <br> c) XRAM is used | a) P0/P2 $\rightarrow$ Bus <br> ( $\overline{R D} / \overline{W R}-$ Data) <br> b) $\overline{R D} / \overline{W R}$ active <br> c) XRAM is used | a) $\mathrm{P} 0 / \mathrm{P} 2 \rightarrow \mathrm{Bus}$ <br> b) $\overline{R D} / \overline{W R}$ active <br> c) ext.memory is used |
| $\overline{\mathrm{MOVX}}$ <br> @ Ri | XPAGE <br> < <br> XRAMCAN <br> addr.page range | a) $\mathrm{PO} \rightarrow \mathrm{Bus}$ $\mathrm{P} 2 \rightarrow \mathrm{I} / \mathrm{O}$ <br> b) $\overline{R D} / \overline{W R}$ active c)ext.memory is used | $\begin{aligned} & \text { a) } \mathrm{P} 0 \rightarrow \mathrm{Bus} \\ & \mathrm{P} 2 \rightarrow \mathrm{I} / \mathrm{O} \end{aligned}$ <br> b) $\overline{\mathrm{RD}} / \overline{W R}$ active c)ext.memory is used | a) $\mathrm{PO} \rightarrow$ Bus P2 $\rightarrow$ I/O <br> b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active c)ext.memory is used | a) $\mathrm{PO} \rightarrow$ Bus P2 $\rightarrow$ I/O <br> b) $\overline{R D} / \overline{W R}$ active c)ext.memory is used | a) $\mathrm{PO} \rightarrow \mathrm{Bus}$ P2 $\rightarrow$ I/O <br> b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active c)ext.memory is used | a) $\mathrm{PO} \rightarrow$ Bus P2 $\rightarrow$ I/O <br> b) $\overline{R D} / \overline{W R}$ active c)ext.memory is used |
|  | XPAGE <br> $\geq$ <br> XRAMCAN <br> addr.page range | a) P0 $\rightarrow$ Bus <br> ( $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$-Data) $\mathrm{P} 2 \rightarrow \mathrm{I} / \mathrm{O}$ <br> b) $\overline{R D} / \overline{W R}$ <br> inactive <br> c) XRAM is used | a) $\mathrm{PO} \rightarrow$ Bus <br> ( $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$-Data only) <br> P2 $\rightarrow$ I/O <br> b) $\overline{R D} / \overline{W R}$ active <br> c)XRAM is used | a) $\mathrm{PO} \rightarrow$ Bus $\mathrm{P} 2 \rightarrow \mathrm{I} / \mathrm{O}$ <br> b) $\overline{R D} / \overline{W R}$ active <br> c)ext.memory is used | a) $\mathrm{P} 2 \rightarrow \mathrm{I} / \mathrm{O}$ <br> $\mathrm{P} 0 / \mathrm{P} 2 \rightarrow \mathrm{I} / \mathrm{O}$ <br> b) $\overline{R D} / \overline{W R}$ <br> inactive <br> c)XRAM is used | a) P0 $\rightarrow$ Bus ( $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$-Data) P2 $\rightarrow$ I/O <br> b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active <br> c)XRAM is used | a) $\mathrm{P} 0 \rightarrow$ Bus $\mathrm{P} 2 \rightarrow \mathrm{I} / \mathrm{O}$ <br> b) $\overline{\mathrm{RD}} / \overline{\mathrm{WR}}$ active <br> c)ext.memory is used |

$\square$ modes compatible to 8051/C501 family
Table 2
Behaviour of P0/P2 and RD/WR During MOVX Accesses

## Reset and System Clock

The reset input is an active low input at pin RESET. Since the reset is synchronized internally, the RESET pin must be held low for at least two machine cycles (12 oscillator periods) while the oscillator is running. A pullup resistor is internally connected to $V_{\mathrm{DD}}$ to allow a power-up reset with an external capacitor only. An automatic reset can be obtained when $V_{D D}$ is applied by connecting the RESET pin to $V_{S S}$ via a capacitor. Figure 6 shows the possible reset circuitries.


Figure 6

## Reset Circuitries

Figure 7 shows the recommended oscillator circiutries for crystal and external clock operation.


Figure 7
Recommended Oscillator Circuitries

## Multiple Datapointers

As a functional enhancement to the standard 8051 architecture, the C515C contains eight 16 -bit datapointers instead of only one datapointer. The instruction set uses just one of these datapointers at a time. The selection of the actual datapointer is done in the special function register DPSEL. Figure 8 illustrates the datapointer addressing mechanism.


Figure 8
External Data Memory Addressing using Multiple Datapointers

## Enhanced Hooks Emulation Concept

The Enhanced Hooks Emulation Concept of the C500 microcontroller family is a new, innovative way to control the execution of C500 MCUs and to gain extensive information on the internal operation of the controllers. Emulation of on-chip ROM based programs is possible, too.

Each production chip has built-in logic for the supprt of the Enhanced Hooks Emulation Concept. Therefore, no costly bond-out chips are necessary for emulation. This also ensure that emulation and production chips are identical.
The Enhanced Hooks Technology ${ }^{\top M}$, which requires embedded logic in the C500 allows the C500 together with an EH-IC to function similar to a bond-out chip. This simplifies the design and reduces costs of an ICE-system. ICE-systems using an EH-IC and a compatible C500 are able to emulate all operating modes of the different versions of the C500 microcontrollers. This includes emulation of ROM, ROM with code rollover and ROMless modes of operation. It is also able to operate in single step mode and to read the SFRs after a break.


Figure 9

## Basic C500 MCU Enhanced Hooks Concept Configuration

Port 0, port 2 and some of the control lines of the C500 based MCU are used by Enhanced Hooks Emulation Concept to control the operation of the device during emulation and to transfer informations about the program execution and data transfer between the external emulation hardware (ICE-system) and the C500 MCU.

## Special Function Registers

The registers, except the program counter and the four general purpose register banks, reside in the special function register area. The special function register area consists of two portions : the standard special function register area and the mapped special function register area. Two special function registers of the C515C (PCON1 and DIR5) are located in the mapped special function register area. For accessing the mapped special function register area, bit RMAP in special function register SYSCON must be set. All other special function registers are located in the standard special function register area which is accessed when RMAP is cleared ("0"). As long as bit RMAP is set, mapped special function register area can be accessed. This bit is not cleared by hardware automatically. Thus, when non-mapped/mapped registers are to be accessed, the bit RMAP must be cleared/set by software, respectively each.

Special Function Register SYSCON (Address B1 ${ }_{H}$ ) Reset Value C515C-8R : X010XX01B Reset Value C515C-8E : X010X001B

| Bit No. | MSB |  |  |  |  |  |  | LSB |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |  |
| ${ }^{B 1}{ }_{H}$ | - | PMOD | EALE | RMAP | - | CSWO | XMAP1 | XMAPO | SYSCON |


| Bit | Function |
| :--- | :--- |
| RMAP | Special function register map bit <br> RMAP $=0:$ The access to the non-mapped (standard) special function <br> register area is enabled (reset value). |
|  | RMAP $=1:$The access to the mapped special function register area is <br> enabled. |

The 59 special function registers (SFRs) in the standard and mapped SFR area include pointers and registers that provide an interface between the CPU and the other on-chip peripherals. The SFRs of the C515C are listed in table 3 and table 4. In table 3 they are organized in groups which refer to the functional blocks of the C515C. The CAN-SFRs are also included in table 3. Table 4 illustrates the contents of the SFRs in numeric order of their addresses. Table 5 list the CAN-SFRs in numeric order of their addresses.

Table 3
Special Function Registers - Functional Blocks

| Block | Symbol | Name | Address | Contents after Reset |
| :---: | :---: | :---: | :---: | :---: |
| CPU | ACC <br> B <br> DPH <br> DPL <br> DPSEL <br> PSW <br> SP <br> SYSCON ${ }^{2}$ | Accumulator <br> B-Register <br> Data Pointer, High Byte <br> Data Pointer, Low Byte <br> Data Pointer Select Register <br> Program Status Word Register <br> Stack Pointer <br> $\begin{array}{ll}\text { System Control Register } & \text { C515C-8R } \\ \text { C515C-8E }\end{array}$ | $\begin{aligned} & \mathrm{EO}_{\mathbf{H}}{ }^{1)} \\ & \mathrm{FO}_{\mathbf{H}}{ }^{1)} \\ & 83_{\mathrm{H}} \\ & 82_{\mathrm{H}} \\ & 92_{\mathrm{H}} \\ & \mathbf{D 0} \mathbf{H}^{1)} \\ & 81_{\mathrm{H}} \\ & \mathrm{~B} 1_{\mathrm{H}} \\ & \mathrm{~B} 1_{\mathrm{H}} \end{aligned}$ | ```\(0^{00} \mathrm{H}\) \({ }^{00} \mathrm{H}\) \({ }^{00} \mathrm{H}\) \({ }^{00} \mathrm{H}\) XXXXX000 \({ }^{3)}\) \({ }^{00} \mathrm{H}\) \({ }^{07} \mathrm{H}\) X010XX01 \({ }^{3)}\) X010X001B \({ }^{3)}\)``` |
| A/DConverter | $\begin{aligned} & \text { ADCON0 }{ }^{2)} \\ & \text { ADCON1 } \\ & \text { ADDATH } \\ & \text { ADDATL } \end{aligned}$ | A/D Converter Control Register 0 A/D Converter Control Register 1 A/D Converter Data Register High Byte A/D Converter Data Register Low Byte | $\begin{aligned} & \text { D8 }_{H}{ }^{1)} \\ & \text { DC }_{H} \\ & D 9_{H} \\ & D A_{H}{ }^{4)} \end{aligned}$ | $\begin{aligned} & 00 \mathrm{H} \\ & 0 \mathrm{XXXX000} \\ & \mathrm{~B}^{3)} \\ & 00_{\mathrm{H}} \\ & 00 X_{X X X X}{ }^{3)} \end{aligned}$ |
| Interrupt System | IENO ${ }^{2)}$ <br> IEN1 ${ }^{\text {2) }}$ <br> IEN2 <br> IPO ${ }^{2)}$ <br> IP1 <br> TCON ${ }^{2)}$ <br> T2CON ${ }^{2)}$ <br> SCON ${ }^{2)}$ <br> IRCON | Interrupt Enable Register 0 Interrupt Enable Register 1 Interrupt Enable Register 2 Interrupt Priority Register 0 Interrupt Priority Register 1 Timer Control Register Timer 2 Control Register Serial Channel Control Register Interrupt Request Control Register |  | $\begin{aligned} & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \\ & \mathrm{XXOOX00X} \mathrm{~B}^{3)} \\ & 00_{\mathrm{H}} \\ & 0 \mathrm{XO}^{3} 0000 \mathrm{~B}^{3)} \\ & 00_{\mathrm{H}} \\ & 0 \mathrm{O}_{\mathrm{H}} \\ & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \end{aligned}$ |
| XRAM | XPAGE <br> SYSCON ${ }^{2}$ | Page Address Register for Extended on-chip XRAM and CAN Controller <br> $\begin{array}{ll}\text { System Control Register } \quad \text { C515C-8R } \\ & \text { C515C-8E }\end{array}$ | $\begin{aligned} & { }^{91} \mathrm{H} \\ & \mathrm{~B} 1_{\mathrm{H}} \\ & \mathrm{~B} 1_{\mathrm{H}} \end{aligned}$ | $\begin{aligned} & 00 \mathrm{H} \\ & \mathrm{X010XX01} \mathrm{~B}^{3)} \\ & \mathrm{X010} \mathrm{\times 001} \mathrm{~B}^{3)} \end{aligned}$ |
| Ports | P0 <br> P1 <br> P2 <br> P3 <br> P4 <br> P5 <br> DIR5 <br> P6 <br> P7 <br> SYSCON ${ }^{2}$ | Port 0 <br> Port 1 <br> Port 2 <br> Port 3 <br> Port 4 <br> Port 5 <br> Port 5 Direction Register <br> Port 6, Analog/Digital Input <br> Port 7 <br> $\begin{array}{ll}\text { System Control Register } & \text { C515C-8R } \\ \text { C515C-8E }\end{array}$ |  | $\mathrm{FF}_{\mathrm{H}}$ <br> $\mathrm{FF}_{\mathrm{H}}$ <br> $\mathrm{FF}_{\mathrm{H}}$ <br> $\mathrm{FF}_{\mathrm{H}}$ <br> $\mathrm{FF}_{\mathrm{H}}$ <br> $\mathrm{FF}_{\mathrm{H}}$ <br> $\mathrm{FF}_{\mathrm{H}}$ <br> XXXXXXX1 ${ }^{3)}$ <br> X010XX01 ${ }^{3)}$ <br> X010X001B ${ }^{3)}$ |

1) Bit-addressable special function registers
2) This special function register is listed repeatedly since some bits of it also belong to other functional blocks.
3) " $X$ " means that the value is undefined and the location is reserved
4) This SFR is a mapped SFR. For accessing this SFR, bit PDIR in SFR IP1 must be set.

Table 3
Special Function Registers - Functional Blocks (cont'd)

| Block | Symbol | Name | Address | Contents after Reset |
| :---: | :---: | :---: | :---: | :---: |
| Serial Channel | ADCONO ${ }^{2}$ <br> PCON ${ }^{2)}$ <br> SBUF <br> SCON <br> SRELL <br> SRELH | A/D Converter Control Register 0 <br> Power Control Register <br> Serial Channel Buffer Register <br> Serial Channel Control Register <br> Serial Channel Reload Register, low byte <br> Serial Channel Reload Register, high byte | $\begin{aligned} & \text { D8 } H^{1} \\ & 87_{H} \\ & 99_{H} \\ & 98_{H}{ }^{1)} \\ & A A_{H} \\ & B A_{H} \\ & \hline \end{aligned}$ | $\begin{array}{\|l\|} \hline 00_{\mathrm{H}} \\ 00_{\mathrm{H}} \\ \text { XX }{ }^{3)} \\ 00_{\mathrm{H}} \\ \mathrm{D} 9_{\mathrm{H}} \\ \text { XXXXX11 }^{3}{ }^{3} \\ \hline \end{array}$ |
| CAN | CR | Control Register | $\mathrm{F}^{7} 00{ }_{\mathrm{H}}$ | ${ }^{01} \mathrm{H}$ |
| Controller | SR | Status Register | $\mathrm{F}^{7} 01_{\mathrm{H}}$ | $\mathrm{XX}^{\text {3) }}$ |
|  | IR | Interrupt Register | F 702 H | $\mathrm{XX}^{\text {H) }}$ |
|  | BTR0 | Bit Timing Register Low | F704H | $\mathrm{UU}_{\mathrm{H}}{ }^{\text {3 }}$ |
|  | BTR1 | Bit Timing Register High | F705H | OUUUUUUU ${ }_{\text {B }}{ }^{3}$ |
|  | GMS0 | Global Mask Short Register Low | F706H | $\mathrm{UU}_{\mathrm{H}}{ }^{3 /}$ |
|  | GMS1 | Global Mask Short Register High | F707H | UUU11111 ${ }^{\text {a }}$ |
|  | UGMLO | Upper Global Mask Long Register Low | $\mathrm{F}^{\text {708 }} \mathrm{H}$ | $\mathrm{UU}_{\mathrm{H}^{3)}}$ |
|  | UGML1 | Upper Global Mask Long Register High | F709H | $\mathrm{UU}_{\mathrm{H}}{ }^{3}$ |
|  | LGMLO | Lower Global Mask Long Register Low | $\mathrm{F}^{\text {70A }} \mathrm{H}$ | $\mathrm{UU}_{\mathrm{H}}{ }^{3)}$ |
|  | LGML1 | Lower Global Mask Long Register High | $\mathrm{F70B}_{\mathrm{H}}$ | UUUUU000 ${ }_{\text {B }}{ }^{\text {3 }}$ |
|  | UMLM0 | Upper Mask of Last Message Register Low | $\mathrm{F}^{\text {P }} \mathrm{C}_{\mathrm{H}}$ | $\mathrm{UU}_{\mathrm{H}^{3)}}$ |
|  | UMLM1 | Upper Mask of Last Message Register High |  | $\mathrm{UU}_{\mathrm{H}}{ }^{3)}$ |
|  | LMLM0 | Lower Mask of Last Message Register Low | $\mathrm{F}^{\text {70E }} \mathrm{H}$ | $\mathrm{UU}_{\mathrm{H}}{ }^{3)}$ |
|  | LMLM1 | Lower Mask of Last Message Register High Message Object Registers : | $\mathrm{F}^{\text {P }} \mathrm{F}_{\mathrm{H}}$ | UUUUU000 ${ }_{\text {B }}{ }^{3 /}$ |
|  | MCRO | Message Control Register Low | $\mathrm{F}_{\mathrm{nn} 0} \mathrm{H}^{5)}$ | $\mathrm{UU}_{\mathrm{H}^{3)}}$ |
|  | MCR1 | Message Control Register High | F7n1 ${ }^{5}$ ) | $\mathrm{UU}_{\mathrm{H}^{3)}}$ |
|  | UAR0 | Upper Arbitration Register Low | F7n2 ${ }^{\text {5) }}$ | $\mathrm{UU}_{\mathrm{H}^{3)}}$ |
|  | UAR1 | Upper Arbitration Register High | F7n3 ${ }^{5}{ }^{5}$ | $\mathrm{UU}_{\mathrm{H}^{3)}}$ |
|  | LAR0 | Lower Arbitration Register Low | F7n4 $\mathrm{H}^{5)}$ | $\mathrm{UU}_{\mathrm{H}^{3)}}$ |
|  | LAR1 | Lower Arbitration Register High | F7n5 ${ }^{5}{ }^{5}$ | UUUUU000 ${ }_{\text {B }}{ }^{3 /}$ |
|  | MCFG | Message Configuration Register | F7n6 ${ }^{\text {5) }}$ | UUUUUU00 ${ }^{\text {3) }}$ |
|  | DB0n | Message Data Byte 0 | F7n7 ${ }^{5}{ }^{5}$ | $X X^{3}{ }^{3}$ |
|  | DB1n | Message Data Byte 1 | $\mathrm{F}_{7} 88 \mathrm{H}^{5}$ | $\mathrm{XX}_{\mathrm{H}^{3)}}$ |
|  | DB2n | Message Data Byte 2 | F7n9 ${ }^{\text {5 }}$ ) | $\mathrm{XX}_{\mathrm{H}^{3)}}$ |
|  | DB3n | Message Data Byte 3 | $\mathrm{F}_{7 n} \mathrm{~A}_{\mathrm{H}}{ }^{5}$ | $\mathrm{XX}_{\mathrm{H}^{3)}}$ |
|  | DB4n | Message Data Byte 4 | $\mathrm{F}_{7 \mathrm{nB}}^{\mathrm{H}}{ }^{5}$ | $\mathrm{XX}_{\mathrm{H}^{3)}}$ |
|  | DB5n | Message Data Byte 5 | $\mathrm{F}_{7 \mathrm{nC}}^{\mathrm{H}}{ }^{5}$ | $\mathrm{XX}_{\mathrm{H}^{3)}}$ |
|  | DB6n | Message Data Byte 6 | F7nD ${ }^{5}{ }^{5}$ | $\mathrm{XX}_{\mathrm{H}^{3)}}$ |
|  | DB7n | Message Data Byte 7 | F7nEH ${ }^{5}$ | $\mathrm{XX}_{\mathrm{H}^{3)}}$ |

1) Bit-addressable special function registers
2) This special function register is listed repeatedly since some bits of it also belong to other functional blocks.
3) " $X$ " means that the value is undefined and the location is reserved. " $U$ " means that the value is unchanged by a reset operation. "U"values are undefined (as " $X$ ") after a power-on reset operation
4) SFR is located in the mapped SFR area. For accessing this SFR, bit RMAP in SFR SYSCON must be set.
5) The notation " $n$ " in the message object address definition defines the number of the related message object.

Table 3
Special Function Registers - Functional Blocks (cont'd)

| Block | Symbol | Name | Address | Contents after Reset |
| :---: | :---: | :---: | :---: | :---: |
| SSC <br> Interface | $\begin{aligned} & \text { SSCCON } \\ & \text { STB } \\ & \text { SRB } \\ & \text { SCF } \\ & \text { SCIEN } \\ & \text { SSCMOD } \end{aligned}$ | SSC Control Register SSC Transmit Buffer SSC Receive Register SSC Flag Register SSC Interrupt Enable Register SSC Mode Test Register | $\begin{aligned} & 93_{H^{1)}} \\ & 94_{\mathrm{H}} \\ & 95_{\mathrm{H}} \\ & A B_{H^{1)}} \\ & A C_{H} \\ & 96_{\mathrm{H}} \end{aligned}$ | $\begin{aligned} & 00_{H} \\ & \text { XX } \left._{H^{3}}\right) \\ & \text { XX }_{H^{3}} \\ & \text { XXXXX00 }^{3)} \\ & \text { XXXXXX00 }^{3)} \\ & 00_{H} \end{aligned}$ |
| Timer 0/ Timer 1 | $\begin{array}{\|l\|} \hline \text { TCON } \\ \text { TH0 } \\ \text { TH1 } \\ \text { TLO } \\ \text { TL1 } \\ \text { TMOD } \end{array}$ | Timer 0/1 Control Register <br> Timer 0, High Byte <br> Timer 1, High Byte <br> Timer 0, Low Byte <br> Timer 1, Low Byte <br> Timer Mode Register | $\begin{aligned} & 88_{H}{ }^{1)} \\ & 8 \mathrm{C}_{\mathrm{H}} \\ & 8 \mathrm{D}_{\mathrm{H}} \\ & 8 \mathrm{~A}_{\mathrm{H}} \\ & 8 \mathrm{~B}_{\mathrm{H}} \\ & 89_{\mathrm{H}} \end{aligned}$ | $\begin{aligned} & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \end{aligned}$ |
| Compare/ <br> Capture <br> Unit / <br> Timer 2 | CCEN <br> CCH1 <br> CCH2 <br> CCH3 <br> CCL1 <br> CCL2 <br> CCL3 <br> CRCH <br> CRCL <br> TH2 <br> TL2 <br> T2CON | Comp./Capture Enable Reg. <br> Comp./Capture Reg. 1, High Byte Comp./Capture Reg. 2, High Byte Comp./Capture Reg. 3, High Byte Comp./Capture Reg. 1, Low Byte Comp./Capture Reg. 2, Low Byte Comp./Capture Reg. 3, Low Byte Com./Rel./Capt. Reg. High Byte Com./Rel./Capt. Reg. Low Byte Timer 2, High Byte Timer 2, Low Byte Timer 2 Control Register | $\mathrm{C}_{\mathrm{H}}$ <br> $\mathrm{C}_{\mathrm{H}}$ <br> ${ }^{\mathrm{C}} \mathrm{S}_{\mathrm{H}}$ <br> ${ }^{\mathrm{C}} \mathrm{H}_{\mathrm{H}}$ <br> $\mathrm{C}_{2} \mathrm{H}$ <br> $\mathrm{C}_{4} \mathrm{H}$ <br> $\mathrm{C}_{6} \mathrm{H}$ <br> $\mathrm{CBH}_{\mathrm{H}}$ <br> $\mathrm{CA}_{\mathrm{H}}$ <br> $\mathrm{CD}_{\mathrm{H}}$ <br> $\mathrm{CC}_{\mathrm{H}}$ <br> $\mathrm{CB}_{\mathrm{H}}{ }^{1)}$ | ${ }^{00} \mathrm{H}$ <br> $0^{00} \mathrm{H}$ <br> $0^{00} \mathrm{H}$ <br> ${ }^{00} \mathrm{H}$ <br> $0^{00} \mathrm{H}$ <br> $0^{00} \mathrm{H}$ <br> $0^{00} \mathrm{H}$ <br> ${ }^{00} \mathrm{H}$ <br> ${ }^{00} \mathrm{H}$ <br> ${ }^{00} \mathrm{H}$ <br> ${ }^{00} \mathrm{H}$ <br> $0^{00} \mathrm{H}$ |
| Watchdog | WDTREL <br> IENO ${ }^{2)}$ <br> IEN1 ${ }^{2)}$ <br> IPO ${ }^{2)}$ | Watchdog Timer Reload Register Interrupt Enable Register 0 Interrupt Enable Register 1 Interrupt Priority Register 0 | $\begin{aligned} & 86 \mathrm{H} \\ & \mathbf{A 8} \mathbf{H}^{11} \\ & \mathbf{B 8} \mathbf{H}^{11} \\ & \mathrm{~A} \mathbf{H}^{1} \end{aligned}$ | $\begin{aligned} & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \\ & 00_{\mathrm{H}} \end{aligned}$ |
| Power Save Modes | $\begin{array}{\|l\|} \hline \text { PCON }{ }^{2} \\ \text { PCON } \end{array}$ | Power Control Register <br> Power Control Register 1 $\begin{aligned} & \text { C515C-8R } \\ & \text { C515C-8E } \end{aligned}$ | $\begin{aligned} & 88_{\mathrm{H}} \\ & 88_{\mathrm{H}}{ }^{4)} \\ & 88_{\mathrm{H}}{ }^{4)} \end{aligned}$ | $\begin{aligned} & 00_{\mathrm{H}} \\ & 0 \times \mathrm{XXXXX} \\ & \mathrm{BX}^{3)} \\ & 0^{3} \mathrm{OXXX}_{\mathrm{B}}{ }^{3)} \end{aligned}$ |

1) Bit-addressable special function registers
2) This special function register is listed repeatedly since some bits of it also belong to other functional blocks.
3) " $X$ " means that the value is undefined and the location is reserved
4) SFR is located in the mapped SFR area. For accessing this SFR, bit RMAP in SFR SYSCON must be set.

Table 4
Contents of the SFRs, SFRs in numeric order of their addresses

| Addr | Register | Content after Reset ${ }^{1)}$ | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $80 \mathrm{H}^{2)}$ | P0 | $\mathrm{FF}_{\mathrm{H}}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| 81 H | SP | $0^{4}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| ${ }^{82} \mathrm{H}$ | DPL | ${ }^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $83^{\text {H }}$ | DPH | $0^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $86_{6}$ | WDTREL | $0^{0} \mathrm{H}$ | WDT PSEL | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| ${ }^{87} \mathrm{H}$ | PCON | ${ }^{00} \mathrm{H}$ | SMOD | PDS | IDLS | SD | GF1 | GFO | PDE | IDLE |
| $88 \mathrm{H}^{2)}$ | TCON | $0^{00} \mathrm{H}$ | TF1 | TR1 | TF0 | TR0 | IE1 | IT1 | IE0 | ITO |
| $88 \mathrm{H}^{3)}$ | PCON1 ${ }^{4}$ | $\begin{aligned} & 0 X X X- \\ & X X X X_{B} \end{aligned}$ | EWPD | - | - | - | - | - | - | - |
| $88 \mathrm{H}^{3)}$ | PCON1 ${ }^{5}$ | $\begin{aligned} & 0 X X 0- \\ & \text { XXXX }_{B} \end{aligned}$ | EWPD | - | - | WS | - | - | - | - |
| $88^{\text {¢ }}$ | TMOD | ${ }^{00} \mathrm{H}$ | GATE | C/T | M1 | M0 | GATE | C/T | M1 | M0 |
| $8 \mathrm{~A}_{\mathrm{H}}$ | TLO | $0^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $8 \mathrm{~B}_{\mathrm{H}}$ | TL1 | $0^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $8 \mathrm{C}_{\mathrm{H}}$ | TH0 | $0^{0} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $8 \mathrm{D}_{\mathrm{H}}$ | TH1 | $0^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $90 \mathrm{H}^{2)}$ | P1 | $\mathrm{FF}_{\mathrm{H}}$ | T2 | $\begin{aligned} & \text { CLK- } \\ & \text { OUT } \end{aligned}$ | T2EX | INT2 | INT6 | INT5 | INT4 | INT3 |
| ${ }^{91} \mathrm{H}$ | XPAGE | ${ }^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $9^{92} \mathrm{H}$ | DPSEL | $\begin{aligned} & \mathrm{XXXX}- \\ & \mathrm{X000} \end{aligned}$ | - | - | - | - | - | . 2 | . 1 | . 0 |
| 93H | SSCCON | $0^{\text {H }}$ | SCEN | TEN | MSTR | CPOL | CPHA | BRS2 | BRS1 | BRS0 |
| ${ }^{94} \mathrm{H}$ | STB | $X X_{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| ${ }^{95} \mathrm{H}$ | SRB | XX ${ }_{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $9^{96} \mathrm{H}$ | SSCMOD | $0^{00}$ | LOOPB | TRIO | 0 | 0 | 0 | 0 | 0 | LSBSM |
| $98 \mathrm{H}^{2)}$ | SCON | $0^{00} \mathrm{H}$ | SM0 | SM1 | SM2 | REN | TB8 | RB8 | TI | RI |
| 99\% | SBUF | XX ${ }_{\text {H }}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |

1) $X$ means that the value is undefined and the location is reserved
2) Bit-addressable special function registers
3) SFR is located in the mapped SFR area. For accessing this SFR, bit RMAP in SFR SYSCON must be set.
4) This SFR is available in the C515C-8R and C515C-L.
5) This SFR is available in the C515C-8E.

Table 4
Contents of the SFRs, SFRs in numeric order of their addresses (cont'd)
$\left.\begin{array}{l|l|l|l|l|l|l|l|l|l|l}\hline \text { Addr } & \text { Register } & \begin{array}{l}\text { Content } \\ \text { after } \\ \text { Reset }\end{array}\end{array}\right)$

1) $X$ means that the value is undefined and the location is reserved
2) Bit-addressable special function registers
3) This SFR is available in the C515C-8R and C515C-L.
4) This SFR is available in the C515C-8E.

Table 4
Contents of the SFRs, SFRs in numeric order of their addresses (cont'd)

| Addr | Register | Content after Reset ${ }^{1)}$ | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{CA}_{\mathrm{H}}$ | CRCL | $0^{0} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{CBH}_{\mathrm{H}}$ | CRCH | $0^{0} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{CCH}_{\mathrm{H}}$ | TL2 | $0^{0} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{CD}_{\mathrm{H}}$ | TH2 | $0^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{DOH}^{2}$ | PSW | $0^{00} \mathrm{H}$ | CY | AC | F0 | RS1 | RS0 | OV | F1 | P |
| $\mathrm{D}^{\text {H }}{ }^{2)}$ | ADCON0 | $0^{00} \mathrm{H}$ | BD | CLK | ADEX | BSY | ADM | MX2 | MX1 | MX0 |
| D9H | ADDATH | $0^{0} \mathrm{H}$ | . 9 | . 8 | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 |
| $\mathrm{DA}_{\mathrm{H}}$ | ADDATL | $\begin{aligned} & 00 X X- \\ & X_{X X X} \end{aligned}$ | . 1 | . 0 | - | - | - | - | - | - |
| $\mathrm{DB}_{\mathrm{H}}$ | P6 | - | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{DCH}_{\mathrm{H}}$ | ADCON1 | $\begin{aligned} & 0 X X X- \\ & \mathrm{XOOO}_{\mathrm{B}} \end{aligned}$ | ADCL | - | - | - | 0 | MX2 | MX1 | MXO |
| $\mathrm{EOH}^{2)}$ | ACC | $0^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{E}_{8} \mathrm{H}^{2)}$ | P4 | $\mathrm{FF}_{\mathrm{H}}$ | RXDC | TXDC | INT8 | SLS | STO | SRI | SCLK | $\overline{\text { ADST }}$ |
| $\mathrm{FOH}^{2)}$ | B | $0^{00} \mathrm{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{F}^{\left(H^{2}\right)}$ | P5 | $\mathrm{FF}_{\mathrm{H}}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{F}_{8} \mathrm{H}^{2)}$ | DIR5 ${ }^{3)}$ | $\mathrm{FF}_{\mathrm{H}}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{FA}_{\mathrm{H}}$ | P7 | $\begin{aligned} & \mathrm{XXXX}- \\ & \mathrm{XXX1} \end{aligned}$ | - | - | - | - | - | - | - | INT7 |
| $\mathrm{FC}_{\mathrm{H}}$ | VR0 4) ${ }^{\text {5 }}$ | $\mathrm{C}^{\mathrm{H}} \mathrm{H}$ | 1 | 1 | 0 | 0 | 0 | 1 | 0 | 1 |
| $\mathrm{FD}_{\mathrm{H}}$ | VR1 ${ }^{4) 5}$ | ${ }^{95} \mathrm{H}$ | 1 | 0 | 0 | 1 | 0 | 1 | 0 | 1 |
| $\mathrm{FE}_{\mathrm{H}}$ | VR2 4) 5) | 6) | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |

1) $X$ means that the value is undefined and the location is reserved
2) Bit-addressable special function registers
3) This SFR is a mapped SFR. For accessing this SFR, bit PDIR in SFR IP1 must be set.
4) This SFR is a mapped SFR. For accessing this SFR, bit RMAP in SFR SYSCON must be set.
5) These SFRs are read-only registers (C515C-8E only).

6 ) The content of this SFR varies with the actual step of the C515C-8E (see also chapter 10-7).

Table 5
Contents of the CAN Registers in numeric order of their addresses

| Addr. <br> $\mathrm{n}=1-\mathrm{F}_{\mathrm{H}}$ <br> 1) | Register | Content after Reset ${ }^{2)}$ | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| F700H | CR | ${ }^{01} \mathrm{H}$ | TEST | CCE | 0 | 0 | EIE | SIE | IE | INIT |
| $\overline{\mathrm{F} 701} \mathrm{H}$ | SR | $X X_{H}$ | BOFF | EWRN | - | RXOK | TXOK | LEC2 | LEC1 | LEC0 |
| ${ }^{\mathrm{F} 702 \mathrm{H}}$ | IR | $X X_{H}$ | INTID |  |  |  |  |  |  |  |
| $\underline{F 704} \mathrm{H}$ | BTR0 | $\mathrm{UU}_{\mathrm{H}}$ | SJW |  | BRP |  |  |  |  |  |
| F705 H | BTR1 | OUUU. $\mathrm{UUUU}_{B}$ | 0 |  | TSEG2 |  | TSEG1 |  |  |  |
| $\mathrm{F}^{706} \mathrm{H}$ | GMS0 | $\mathrm{UU}_{\mathrm{H}}$ | ID28-21 |  |  |  |  |  |  |  |
| F707H | GMS1 | $\begin{aligned} & \text { UUU1. } \\ & \text { 1111 }_{\mathrm{B}} \end{aligned}$ | ID20-18 |  |  | 1 | 1 | 1 | 1 | 1 |
| F708H | UGMLO | $\mathrm{UU}_{\mathrm{H}}$ | ID28-21 |  |  |  |  |  |  |  |
| $\mathrm{F}^{709} \mathrm{H}$ | UGML1 | $\mathrm{UU}_{\mathrm{H}}$ | ID20-13 |  |  |  |  |  |  |  |
| $\mathrm{F70A}_{\mathrm{H}}$ | LGMLO | $\mathrm{UU}_{\mathrm{H}}$ | ID12-5 |  |  |  |  |  |  |  |
| $\mathrm{F}^{\text {70B }} \mathrm{H}$ | LGML1 | $\begin{aligned} & \text { UUUU. } \\ & \text { U000 } \end{aligned}$ | ID4-0 |  |  |  |  | 0 | 0 | 0 |
| $\mathrm{F}^{\text {70C }} \mathrm{H}$ | UMLM0 | $\mathrm{UU}_{\mathrm{H}}$ | ID28-21 |  |  |  |  |  |  |  |
| $\mathrm{F70D}_{\mathrm{H}}$ | UMLM1 | $\mathrm{UU}_{\mathrm{H}}$ | ID20-18 |  |  | ID17-13 |  |  |  |  |
| $\mathrm{F70E}_{\mathrm{H}}$ | LMLMO | $\mathrm{UU}_{\mathrm{H}}$ | ID12-5 |  |  |  |  |  |  |  |
| ${\mathrm{F} 70 \mathrm{~F}_{\mathrm{H}}}$ | LMLM1 | UUUU. U000B | ID4-0 |  |  |  |  | 0 | 0 | 0 |
| $\mathrm{F7n0}_{\mathrm{H}}$ | MCRO | $\mathrm{UU}_{\mathrm{H}}$ | MSG | GVAL | TXIE |  | RXIE |  | INTPND |  |
| $\mathrm{F}^{\text {nn1 }} \mathrm{H}$ | MCR1 | $\mathrm{UU}_{\mathrm{H}}$ | RMT | PND |  | RQ | MSGLST CPUUPD |  | NEWDAT |  |
| F7n2 ${ }^{\text {H }}$ | UAR0 | $\mathrm{UU}_{\mathrm{H}}$ | ID28-21 |  |  |  |  |  |  |  |
| $\mathrm{F}^{\text {7n3 }} \mathrm{H}$ | UAR1 | $\mathrm{UU}_{\mathrm{H}}$ | ID20-18 |  |  | ID17-13 |  |  |  |  |
| F7n4 H | LAR0 | $\mathrm{UU}_{\mathrm{H}}$ | ID12-5 |  |  |  |  |  |  |  |
| F7n5 ${ }_{\text {H }}$ | LAR1 | UUUU. U000B | ID4-0 |  |  |  |  | 0 | 0 | 0 |
| F7n6 ${ }_{\text {H }}$ | MCFG | UUUU. UU00B | DLC |  |  |  | DIR | XTD | 0 | 0 |

1) The notation " $n$ " in the address definition defines the number of the related message object.
2) " $X$ " means that the value is undefined and the location is reserved. "U" means that the value is unchanged by a reset operation. "U" values are undefined (as "X") after a power-on reset operation

Table 5
Contents of the CAN Registers in numeric order of their addresses (cont'd)

| Addr. <br> $\mathrm{n}=1-\mathrm{F}_{\mathrm{H}}$ <br> 1) | Register | Content after Reset ${ }^{2)}$ | Bit 7 | Bit 6 | Bit 5 | Bit 4 | Bit 3 | Bit 2 | Bit 1 | Bit 0 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| F7n7H | DB0n | XX ${ }_{\text {H }}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| ${ }^{\text {F7n8 }}$ H | DB1n | $X X_{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| ${ }^{\text {F7n9 }} \mathrm{H}$ | DB2n | XX ${ }_{\text {H }}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{F7nA}_{\mathrm{H}}$ | DB3n | XX ${ }_{\text {H }}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{F} 7 \mathrm{nB}_{\mathrm{H}}$ | DB4n | $X X_{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{F7nC}_{\mathrm{H}}$ | DB5n | $X X_{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{F7nD}_{\mathrm{H}}$ | DB6n | $X X_{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |
| $\mathrm{F} 7 \mathrm{nE}_{\mathrm{H}}$ | DB7n | XX ${ }_{H}$ | . 7 | . 6 | . 5 | . 4 | . 3 | . 2 | . 1 | . 0 |

1) The notation " $n$ " in the address definition defines the number of the related message object.
2) " $X$ " means that the value is undefined and the location is reserved. " $U$ " means that the value is unchanged by a reset operation. "U" values are undefined (as "X") after a power-on reset operation

## Digital I/O Ports

The C515C allows for digital I/O on 49 lines grouped into 6 bidirectional 8 -bit ports and one 1-bit port. Each port bit consists of a latch, an output driver and an input buffer. Read and write accesses to the I/O ports P0 through P7 are performed via their corresponding special function registers P0 to P 7 . The port structure of port 5 of the C 515 C is especially designed to operate either as a quasibidirectional port structure, compatible to the standard 8051-Family, or as a genuine bidirectional port structure. This port operating mode can be selected by software (setting or clearing the bit PMOD in the SFR SYSCON).

The output drivers of port 0 and 2 and the input buffers of port 0 are also used for accessing external memory. In this application, port 0 outputs the low byte of the external memory address, timemultiplexed with the byte being written or read. Port 2 outputs the high byte of the external memory address when the address is 16 bits wide. Otherwise, the port 2 pins continue emitting the P2 SFR contents.

## Analog Input Ports

Ports 6 is available as input port only and provides two functions. When used as digital inputs, the corresponding SFR P6 contains the digital value applied to the port 6 lines. When used for analog inputs the desired analog channel is selected by a three-bit field in SFR ADCON0 or SFR ADCON1. Of course, it makes no sense to output a value to these input-only ports by writing to the SFR P6. This will have no effect.

If a digital value is to be read, the voltage levels are to be held within the input voltage specifications ( $V_{\mathrm{IL}} / V_{\mathrm{IH}}$ ). Since P 6 is not bit-addressable, all input lines of P6 are read at the same time by byte instructions.

Nevertheless, it is possible to use port 6 simultaneously for analog and digital input. However, care must be taken that all bits of P6 that have an undetermined value caused by their analog function are masked.

## Port Structure Selection of Port 5

After a reset operation of the C515C, the quasi-bidirectional 8051-compatible port structure is selected. For selection of the bidirectional (CMOS) port 5 structure the bit PMOD of SFR SYSCON must be set. Because each port 5 pin can be programmed as an input or an output, additionally, after the selection of the bidirectional mode the direction register DIR5 of port 5 must be written. This direction register is mapped to the port 5 register. This means, the port register address is equal to its direction register address. Figure 10 illustrates the port- and direction register configuration.


Figure 10
Port Register, Direction Register

## Timer / Counter 0 and 1

Timer/Counter 0 and 1 can be used in four operating modes as listed in table 6 :
Table 6
Timer/Counter 0 and 1 Operating Modes

| Mode | Description | TMOD |  | Timer/Counter Input Clock |  |
| :--- | :--- | :---: | :---: | :---: | :---: |
|  |  | M1 | M0 | internal | external (max) |
| 0 | 8-bit timer/counter with a <br> divide-by-32 prescaler | 0 | 0 | $f_{\text {Osd }} / 6 \times 32$ | $f_{\text {OSd }} / 12 \times 32$ |
| 1 | 16-bit timer/counter | 0 | 1 |  |  |
| 2 | 8-bit timer/counter with <br> 8-bit autoreload | 1 | 0 | $f_{\text {osd }} / 6$ | $f_{\text {osd }} / 12$ |
| 3 | Timer/counter 0 used as one <br> 8-bit timer/counter and one | 1 | 1 |  |  |

In the "timer" function ( $\mathrm{C} / \overline{\mathrm{T}}=$ ' 0 ') the register is incremented every machine cycle. Therefore the count rate is $f_{\text {osc }} / 6$.

In the "counter" function the register is incremented in response to a 1-to-0 transition at its corresponding external input pin (P3.4/T0, P3.5/T1). Since it takes two machine cycles to detect a falling edge the max. count rate is $f_{\text {osc }} / 12$. External inputs $\overline{\mathrm{NTO}}$ and $\overline{\mathrm{NT} 1}$ (P3.2, P3.3) can be programmed to function as a gate to facilitate pulse width measurements. Figure 11 illustrates the input clock logic


Figure 11

## Timer/Counter 0 and 1 Input Clock Logic

## Timer/Counter 2 with Compare/Capture/Reload

The timer 2 of the C515C provides additional compare/capture/reload features. which allow the selection of the following operating modes:

- Compare : up to 4 PWM signals with 16 -bit/600 ns resolution
- Capture : up to 4 high speed capture inputs with 600 ns resolution
- Reload : modulation of timer 2 cycle time

The block diagram in figure 12 shows the general configuration of timer 2 with the additional compare/capture/reload registers. The I/O pins which can used for timer 2 control are located as multifunctional port functions at port 1.


Figure 12

## Timer 2 Block Diagram

## Timer 2 Operating Modes

The timer 2, which is a 16 -bit-wide register, can operate as timer, event counter, or gated timer. A roll-over of the count value in TL2/TH2 from all 1's to all 0's sets the timer overflow flag TF2 in SFR IRCON, which can generate an interrupt. The bits in register T2CON are used to control the timer 2 operation.
Timer Mode: In timer function, the count rate is derived from the oscillator frequency. A prescaler offers the possibility of selecting a count rate of $1 / 6$ or $1 / 12$ of the oscillator frequency.
Gated Timer Mode: In gated timer function, the external input pin T2 (P1.7) functions as a gate to the input of timer 2. If T2 is high, the internal clock input is gated to the timer. T2 = 0 stops the counting procedure. This facilitates pulse width measurements. The external gate signal is sampled once every machine cycle.

Event Counter Mode: In the event counter function. the timer 2 is incremented in response to a 1-to-0 transition at its corresponding external input pin T2 (P1.7). In this function, the external input is sampled every machine cycle. Since it takes two machine cycles (12 oscillator periods) to recognize a 1-to-0 transition, the maximum count rate is $1 / 6$ of the oscillator frequency. There are no restrictions on the duty cycle of the external input signal, but to ensure that a given level is sampled at least once before it changes, it must be held for at least one full machine cycle.
Reload of Timer 2: Two reload modes are selectable:
In mode 0, when timer 2 rolls over from all 1's to all 0's, it not only sets TF2 but also causes the timer 2 registers to be loaded with the 16-bit value in the CRC register, which is preset by software. In mode 1, a 16-bit reload from the CRC register is caused by a negative transition at the corresponding input pin P1.5/T2EX. This transition will also set flag EXF2 if bit EXEN2 in SFR IEN1 has been set.

## Timer 2 Compare Modes

The compare function of a timer/register combination operates as follows : the 16-bit value stored in a compare or compare/capture register is compared with the contents of the timer register; if the count value in the timer register matches the stored value, an appropriate output signal is generated at a corresponding port pin and an interrupt can be generated.

## Compare Mode 0

In compare mode 0 , upon matching the timer and compare register contents, the output signal changes from low to high. It goes back to a low level on timer overflow. As long as compare mode 0 is enabled, the appropriate output pin is controlled by the timer circuit only and writing to the port will have no effect. Figure 13 shows a functional diagram of a port circuit when used in compare mode 0 . The port latch is directly controlled by the timer overflow and compare match signals. The input line from the internal bus and the write-to-latch line of the port latch are disconnected when compare mode 0 is enabled.


Figure 13
Port Latch in Compare Mode 0

## Compare Mode 1

If compare mode 1 is enabled and the software writes to the appropriate output latch at the port, the new value will not appear at the output pin until the next compare match occurs. Thus, it can be choosen whether the output signal has to make a new transition (1-to-0 or 0-to-1, depending on the actual pin-level) or should keep its old value at the time when the timer value matches the stored compare value.

In compare mode 1 (see figure 14) the port circuit consists of two separate latches. One latch (which acts as a "shadow latch") can be written under software control, but its value will only be transferred to the port latch (and thus to the port pin) when a compare match occurs.


Figure 14

## Compare Function in Compare Mode 1

## Serial Interface (USART)

The serial port is full duplex and can operate in four modes (one synchronous mode, three asynchronous modes) as illustrated in table 7.

## Table 7 <br> USART Operating Modes

| Mode | SCON |  | Description |  |
| :--- | :---: | :---: | :--- | :---: |
|  | SMO | SM1 |  |  |
| 0 | 0 | 0 | Shift register mode, fixed baud rate <br> Serial data enters and exits through $\mathrm{R} \times \mathrm{D} ; \mathrm{T} \times \mathrm{D}$ outputs the shift <br> clock; 8-bit are transmitted/received (LSB first) |  |
| 1 | 0 | 1 | 8-bit UART, variable baud rate <br> 10 bits are transmitted (through $\mathrm{T} \times \mathrm{D}$ ) or received (at $\mathrm{R} \times \mathrm{D}$ ) |  |
| 2 | 1 | 0 | 9-bit UART, fixed baud rate <br> 11 bits are transmitted (through T $\times \mathrm{D}$ ) or received (at $\mathrm{R} \times \mathrm{D}$ ) |  |
| 3 | 1 | 1 | 9-bit UART, variable baud rate <br> Like mode 2 |  |

For clarification some terms regarding the difference between "baud rate clock" and "baud rate" should be mentioned. In the asynchronous modes the serial interfaces require a clock rate which is 16 times the baud rate for internal synchronization. Therefore, the baud rate generators/timers have to provide a "baud rate clock" (output signal in figure 15 to the serial interface which - there divided by 16 - results in the actual "baud rate". Further, the abrevation $f_{\text {osc }}$ refers to the oscillator frequency (crystal or external clock operation).

The variable baud rates for modes 1 and 3 of the serial interface can be derived either from timer 1 or from a decdicated baud rate generator (see figure 15).
$\qquad$


Figure 15

## Block Diagram of Baud Rate Generation for the Serial Interface

Table 8 below lists the values/formulas for the baud rate calculation of the serial interface with its dependencies of the control bits BD and SMOD.

Table 8
Serial Interface - Baud Rate Dependencies

| Serial Interface Operating Modes | Active Control Bits |  | Baud Rate Calculation |
| :---: | :---: | :---: | :---: |
|  | BD | SMOD |  |
| Mode 0 (Shift Register) | - | - | $f_{\text {osc }} / 6$ |
| Mode 1 (8-bit UART) Mode 3 (9-bit UART) | 0 | X | Controlled by timer 1 overflow : (2 $2^{\text {SMOD }} \times$ timer 1 overflow rate) / 32 |
|  | 1 | X | Controlled by baud rate generator $\left(2^{\text {SMOD }} \times f_{\text {OSC }}\right) /$ <br> ( $32 \times$ baud rate generator overflow rate) |
| Mode 2 (9-bit UART) | - | $\begin{aligned} & 0 \\ & 1 \end{aligned}$ | $f_{\text {osc }} / 32$ <br> $f_{\text {osc }} / 16$ |

## SSC Interface

The C515C microcontroller provides a Synchronous Serial Channel unit, the SSC. This interface is compatible to the popular SPI serial bus interface. Figure 16 shows the block diagram of the SSC. The central element of the SSC is an 8-bit shift register. The input and the output of this shift register are each connected via a control logic to the pin P4.2 / SRI (SSC Receiver In) and P4.3 / STO (SSC Transmitter Out). This shift register can be written to (SFR STB) and can be read through the Receive Buffer Register SRB.


Figure 16

## SSC Block Diagram

The SSC has implemented a clock control circuit, which can generate the clock via a baud rate generator in the master mode, or receive the transfer clock in the slave mode. The clock signal is fully programmable for clock polarity and phase. The pin used for the clock signal is P4.1/ SCLK. When operating in slave mode, a slave select input is provided which enables the SSC interface and also will control the transmitter output. The pin used for this is P4.4 / SLS.
The SSC control block is responsible for controlling the different modes and operation of the SSC, checking the status, and generating the respective status and interrupt signals.

## CAN Controller

The on-chip CAN controller is the functional heart which provides all resources that are required to run the standard CAN protocol (11-bit identifiers) as well as the extended CAN protocol (29-bit identifiers). It provides a sophisticated object layer to relieve the CPU of as much overhead as possible when controlling many different message objects (up to 15). This includes bus arbitration, resending of garbled messages, error handling, interrupt generation, etc. In order to implement the physical layer, external components have to be connected to the C515C.
The internal bus interface connects the on-chip CAN controller to the internal bus of the microcontroller. The registers and data locations of the CAN interface are mapped to a specific 256 byte wide address range of the external data memory area ( $\mathrm{F} 700_{\mathrm{H}}$ to $\mathrm{FFFF}_{\mathrm{H}}$ ) and can be accessed using MOVX instructions. Figure 17 shows a block diagram of the on-chip CAN controller.


Figure 17
CAN Controller Block Diagram

The TX/RX Shift Register holds the destuffed bit stream from the bus line to allow the parallel access to the whole data or remote frame for the acceptance match test and the parallel transfer of the frame to and from the Intelligent Memory.
The Bit Stream Processor (BSP) is a sequencer controlling the sequential data stream between the TX/RX Shift Register, the CRC Register, and the bus line. The BSP also controls the EML and the parallel data stream between the TX/RX Shift Register and the Intelligent Memory such that the processes of reception, arbitration, transmission, and error signalling are performed according to the CAN protocol. Note that the automatic retransmission of messages which have been corrupted by noise or other external error conditions on the bus line is handled by the BSP.

The Cyclic Redundancy Check Register (CRC) generates the Cyclic Redundancy Check code to be transmitted after the data bytes and checks the CRC code of incoming messages. This is done by dividing the data stream by the code generator polynomial.

The Error Management Logic (EML) is responsible for the fault confinement of the CAN device. Its counters, the Receive Error Counter and the Transmit Error Counter, are incremented and decremented by commands from the Bit Stream Processor. According to the values of the error counters, the CAN controller is set into the states error active, error passive and busoff.
The Bit Timing Logic (BTL) monitors the busline input RXDC and handles the busline related bit timing according to the CAN protocol. The BTL synchronizes on a recessive to dominant busline transition at Start of Frame (hard synchronization) and on any further recessive to dominant busline transition, if the CAN controller itself does not transmit a dominant bit (resynchronization). The BTL also provides programmable time segments to compensate for the propagation delay time and for phase shifts and to define the position of the Sample Point in the bit time. The programming of the BTL depends on the baudrate and on external physical delay times.
The Intelligent Memory (CAM/RAM array) provides storage for up to 15 message objects of maximum 8 data bytes length. Each of these objects has a unique identifier and its own set of control and status bits. After the initial configuration, the Intelligent Memory can handle the reception and transmission of data without further microcontroller actions.

## Switch-off Capability of the CAN Cntroller (C515C-8E only)

For power consumption reasons, the on-chip CAN controller in the C515C-8E can be switched off by setting bit CSWO (bit 2) in SFR SYSCON. When the CAN controller is switched off its clock signal is turned off and the operation of the CAN controller is stopped. This switch-off state of the CAN controller is equal to its state in software power down mode. After clearing bit CSWO again the CAN controller has to be reconfigured.

## 10-Bit A/D Converter

The C515C includes a high performance / high speed 10-bit A/D-Converter (ADC) with 8 analog input channels. It operates with a successive approximation technique and uses self calibration mechanisms for reduction and compensation of offset and linearity errors. The A/D converter provides the following features:

- 8 multiplexed input channels (port 6), which can also be used as digital inputs
- 10-bit resolution
- Single or continuous conversion mode
- Internal or external start-of-conversion trigger capability
- Interrupt request generation after each conversion
- Using successive approximation conversion technique via a capacitor array
- Built-in hidden calibration of offset and linearity errors

The main functional blocks of the A/D converter are shown in figure 19.
The $A / D$ converter uses basically two clock signals for operation : the input clock $f_{I N}\left(=1 / t_{\mid N}\right)$ and the conversion clock $\mathrm{f}_{\mathrm{ADC}}\left(=1 / \mathrm{t}_{\mathrm{ADC}}\right)$. These clock signals are derived from the C515C system clock $f_{O S C}$ which is applied at the XTAL pins. The input clock $f_{I N}$ is equal to $f_{O S C}$. The conversion clock is limited to a maximum frequency of 2 MHz and therefore must be adapted to fosc by programming the conversion clock prescaler. The table in figure 18 shows the prescaler ratios and the resulting A/D conversion times which must be selected for typical system clock rates.


Figure 18

## A/D Converter Clock Selection



Figure 19

## A/D Converter Block Diagram

## Interrupt System

The C515C provides 17 interrupt sources with four priority levels. Seven interrupts can be generated by the on-chip peripherals (timer 0 , timer 1 , timer 2, serial interface, A/D converter, SSC interface, CAN controller), and ten interrupts may be triggered externally (P1.5/T2EX, P3.2/INT0, P3.3/INT1, P1.4/INT2, P1.0//्NT3, P1.1/INT4, P1.2/INT5, P1.3/INT6, P7.0/INT7, P4.5/INT8). The wake-up from power-down mode interrupt has a special functionality which allows to exit from the software power-down mode by a short low pulse at pin P3.2/INT0.
In the C515C the 17 interrupt sources are combined to six groups of two or three interrupt sources. Each interrupt group can be programmed to one of the four interrupt priority levels. Figure 20 to 22 give a general overview of the interrupt sources and illustrate the interrupt request and control flags.


Figure 20

## Interrupt Request Sources (Part 1)



Figure 21
Interrupt Request Sources (Part 2)


Figure 22

## Interrupt Request Sources (Part 3)

## Table 9

Interrupt Source and Vectors

| Interrupt Source | Interrupt Vector Address | Interrupt Request Flags |
| :--- | :--- | :--- |
| External Interrupt 0 | $0003_{\mathrm{H}}$ | IE0 |
| Timer 0 Overflow | $000 \mathrm{~B}_{\mathrm{H}}$ | TF0 |
| External Interrupt 1 | $0013_{\mathrm{H}}$ | IE1 |
| Timer 1 Overflow | $001 \mathrm{~B}_{\mathrm{H}}$ | TF1 |
| Serial Channel | $0023_{\mathrm{H}}$ | RI / TI |
| Timer 2 Overflow / Ext. Reload | $002 \mathrm{~B}_{\mathrm{H}}$ | TF2 / EXF2 |
| A/D Converter | $0043_{\mathrm{H}}$ | IADC |
| External Interrupt 2 | $004 \mathrm{~B}_{\mathrm{H}}$ | IEX2 |
| External Interrupt 3 | $0053_{\mathrm{H}}$ | IEX3 |
| External Interrupt 4 | $00 \mathrm{~B}_{\mathrm{H}}$ | IEX4 |
| External Interrupt 5 | $0063_{\mathrm{H}}$ | IEX5 |
| External Interrupt 6 | $006 \mathrm{~B}_{\mathrm{H}}$ | IEX6 |
| Wake-up from power-down mode | $007 \mathrm{~B}_{\mathrm{H}}$ | - |
| CAN controller | $008 \mathrm{~B}_{\mathrm{H}}$ | - |
| External Interrupt 7 | $00 \mathrm{~A}_{\mathrm{H}}$ | - |
| External Interrupt 8 | $00 \mathrm{AB}_{\mathrm{H}}$ | - |
| SSC interface | $003_{\mathrm{H}}$ | TC / WCOL |

## Fail Save Mechanisms

The C515C offers two on-chip peripherals which monitor the program flow and ensure an automatic "fail-safe" reaction for cases where the controller's hardware fails or the software hangs up:

- A programmable watchdog timer (WDT) with variable time-out period from 512 microseconds up to approx. 1.1 seconds at 6 MHz .
- An oscillator watchdog (OWD) which monitors the on-chip oscillator and forces the microcontroller into reset state in case the on-chip oscillator fails; it also provides the clock for a fast internal reset after power-on.


## Programmable Watchdog Timer

The watchdog timer in the C515C is a 15 -bit timer, which is incremented by a count rate of $f_{\text {osc }} / 6$ up to $f_{\text {osd }} / 192$. For programming of the watchdog timer overflow rate, the upper 7 bit of the watchdog timer can be written. Figure 23 shows the block diagram of the watchdog timer unit.


Figure 23
Block Diagram of the Programmable Watchdog Timer
The watchdog timer can be started by software (bit SWDT) or by hardware through pin PE/SWD, but it cannot be stopped during active mode of the C515C. If the software fails to refresh the running watchdog timer an internal reset will be initiated on watchdog timer overflow. For refreshing of the watchdog timer the content of the SFR WDTREL is transfered to the upper 7-bit of the watchdog timer. The refresh sequence consists of two consequtive instructions which set the bits WDT and SWDT each. The reset cause (external reset or reset caused by the watchdog) can be examined by software (flag WDTS). It must be noted, however, that the watchdog timer is halted during the idle mode and power down mode of the processor.

## Oscillator Watchdog

The oscillator watchdog unit serves for four functions:

- Monitoring of the on-chip oscillator's function

The watchdog supervises the on-chip oscillator's frequency; if it is lower than the frequency of the auxiliary RC oscillator in the watchdog unit, the internal clock is supplied by the RC oscillator and the device is brought into reset; if the failure condition disappears (i.e. the onchip oscillator has a higher frequency than the RC oscillator), the part executes a final reset phase of typ. 1 ms in order to allow the oscillator to stabilize; then the oscillator watchdog reset is released and the part starts program execution again.

- Fast internal reset after power-on

The oscillator watchdog unit provides a clock supply for the reset before the on-chip oscillator has started. The oscillator watchdog unit also works identically to the monitoring function.

- Restart from the hardware power down mode.

If the hardware power down mode is terminated the oscillator watchdog has to control the correct start-up of the on-chip oscillator and to restart the program. The oscillator watchdog function is only part of the complete hardware power down sequence; however, the watchdog works identically to the monitoring function.

- Control of external wake-up from software power-down mode When the software power-down mode is left by a low level at the P3.2/INT0 pin, the oscillator watchdog unit assures that the microcontroller resumes operation (execution of the powerdown wake-up interrupt) with the nominal clock rate. In the power-down mode the RC oscillator and the on-chip oscillator are stopped. Both oscillators are started again when power-down mode is released. When the on-chip oscillator has a higher frequency than the RC oscillator, the microcontroller starts operation after a final delay of typ. 1 ms in order to allow the on-chip oscillator to stabilize.


Figure 24
Block Diagram of the Oscillator Watchdog

## Power Saving Modes

The C515C provides two basic power saving modes, the idle mode and the power down mode. Additionally, a slow down mode is available. This power saving mode reduces the internal clock rate in normal operating mode and it can be also used for further power reduction in idle mode.

## - Idle mode

The CPU is gated off from the oscillator. All peripherals are still provided with the clock and are able to work. Idle mode is entered by software and can be left by an interrupt or reset.

## - Power down mode

The operation of the C515C is completely stopped and the oscillator is turned off. This mode is used to save the contents of the internal RAM with a very low standby current.
Software power down mode : Software power down mode is entered by software and can be left by reset or by a short low pulse at pin P3.2//NT0 (or P4.7/RXDC, C515C-8E only).
Hardware power down mode : Hardware power down mode is entered when the pin HWPD is put to low level.

## - Slow-down mode

The controller keeps up the full operating functionality, but its normal clock frequency is internally divided by 32 . This slows down all parts of the controller, the CPU and all peripherals, to $1 / 32$-th of their normal operating frequency. Slowing down the frequency significantly reduces power consumption. The slow down mode can be combined with the idle mode.

Table 10 gives a general overview of the entry and exit conditions of the power saving modes.
Table 10
Power Saving Modes Overview

| Mode | Entering <br> (2-Instruction <br> Example | Leaving by | Remarks |
| :--- | :--- | :--- | :--- |
| Idle mode | ORL PCON, \#01H <br> ORL PCON, \#20H | Ocurrence of an <br> interrupt from a <br> peripheral unit | CPU clock is stopped; <br> CPU maintains their data; <br> peripheral units are active (if <br> enabled) and provided with <br> clock |
|  | Hardware Reset |  |  |

In the power down mode of operation, $V_{\mathrm{DD}}$ can be reduced to minimize power consumption. It must be ensured, however, that $V_{\mathrm{DD}}$ is not reduced before the power down mode is invoked, and that $V_{\mathrm{DD}}$ is restored to its normal operating level, before the power down mode is terminated.

If e.g. the idle mode is left through an interrupt, the microcontroller state (CPU, ports, peripherals) remains preserved. If a power saving mode is left by a hardware reset, the microcontroller state is disturbed and replaced by the reset state of the C515C.
If WS (bit 4) is SFR PCON1 is set (C515C-8E only), pin P4.7/RXDC is alternatively selected as wake-up pin for the software power down mode. If WS (bit 4) is SFR PCON1 is cleared (C515C-8E only), pin P3.2//NT0 is selected as wake-up pin for the software power down mode.
For the C515C-8R, P3.2/INT0 is always selected as wake-up pin.

## OTP Memory Operation (C515C-8E only)

The C515C-8E contains a 64k byte one-time programmable (OTP) program memory. With the C515C-8E fast programming cycles are achieved ( 1 byte in $100 \mu \mathrm{sec}$ ). Also several levels of OTP memory protection can be selected.
For programming of the device, the C515C-8E must be put into the programming mode. This typically is done not in-system but in a special programming hardware. In the programming mode the C515C-8E operates as a slave device similar as an EPROM standalone memory device and must be controlled with address/data information, control lines, and an external 11.5 V programming voltage. Figure 25 shows the pins of the C515C-8E which are required for controlling of the OTP programming mode.


Figure 25
Programming Mode Configuration oof the C515C-8E

## C515C-8E Pin Configuration in Programming Mode



Figure 26
P-MQFP-80 Pin Configuration of the C515C-8E in Programming Mode (Top View)

The following table 11 contains the functional description of all C515C-8E pins which are required for OTP memory programming.

Table 11
Pin Definitions and Functions in Programming Mode

| Symbol | Pin Number | 1/0*) | Function |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: |
| RESET | 1 | 1 | Reset <br> This input must be at static "0" (active) level during the whole programming mode. |  |  |
| PMSELO <br> PMSEL1 | $\begin{aligned} & 15 \\ & 16 \end{aligned}$ | 1 | Programming mode selection pins <br> These pins are used to select the different access modes in programming mode. PMSEL1,0 must satisfy a setup time to the rising edge of PALE. When the logic level of PMSEL1,0 is changed, PALE must be at low level. |  |  |
|  |  |  | PMSEL1 | PMSELO | Access Mode |
|  |  |  | 0 | 0 | Reserved |
|  |  |  | 0 | 1 | Read version bytes |
|  |  |  |  | 0 | Program/read lock bits |
|  |  |  | 1 | 1 | Program/read OTP memory byte |
| $\overline{\text { PSEL }}$ | 17 | 1 | Basic programming mode select <br> This input is used for the basic programming mode selection and must be switched according figure 27. |  |  |
| $\overline{\text { PRD }}$ | 18 | I | Programming mode read strobe <br> This input is used for read access control for OTP memory read, version byte read, and lock bit read operations. |  |  |
| PALE | 19 | I | Programming address latch enable <br> PALE is used to latch the high address lines. The high address lines must satisfy a setup and hold time to/from the falling edge of PALE. PALE must be at low level whenever the logic level of PMSEL1,0 is changed. |  |  |
| XTAL2 | 36 | 1 | XTAL2 <br> Input to the oscillator amplifier. |  |  |
| XTAL1 | 37 | 0 | XTAL1 <br> Output of the inverting oscillator amplifier. |  |  |
| A0/A8 A7/A15 | 38-45 | I | Address lines <br> P2.0-7 are used as multiplexed address input lines A0-A7 and A8-A15. A8-A15 must be latched with PALE. |  |  |

[^4]Table 11
Pin Definitions and Functions in Programming Mode (cont'd)

| Symbol | Pin Number | I/O*) | Function |
| :---: | :---: | :---: | :---: |
| PSEN | 47 | 1 | Program store enable <br> This input must be at static "0" level during the whole programming mode. |
| $\overline{\text { PROG }}$ | 48 | I | Programming mode write strobe <br> This input is used in programming mode as a write strobe for OTP memory program and lock bit write operations. During basic programming mode selection a low level must be applied to PROG. |
| $\overline{\mathrm{EA}} / \mathrm{V}_{\mathrm{PP}}$ | 49 | I | External Access / Programming voltage <br> This pin must be at $11.5 \mathrm{~V}\left(\mathrm{~V}_{\mathrm{PP}}\right)$ voltage level during programming of an OTP memory byte or lock bit. During an OTP memory read operation this pin must be at high level ( $\mathrm{V}_{\mathrm{IH}}$ ). This pin is also used for basic programming mode selection. At basic programming mode selection a low level must be applied to $\overline{\mathrm{EA}} / \mathrm{V}_{\mathrm{Pp}}$. |
| D0-7 | 52-58 | I/O | Data lines 0-7 <br> During programming mode, data bytes are read or written from or to the C515C-8E via the bidirectional D0-7 which are located at port 0 . |
| $\mathrm{V}_{\text {SS }}$ | $\begin{aligned} & 13,34,35, \\ & 51,70 \end{aligned}$ | - | Circuit ground potential must be applied to these pins in programming mode. |
| $\mathrm{V}_{\mathrm{CC}}$ | $\begin{aligned} & 14,32,33, \\ & 50,69 \end{aligned}$ | - | Power supply terminal must be applied to these pins in programming mode. |
| N.C. | $\begin{aligned} & 2-12,20-31, \\ & 46,60-67,69, \\ & 71-80 \end{aligned}$ | - | Not Connected <br> These pins should not be connected in programming mode. |

*) $1=$ Input
$\mathrm{O}=$ Output

## C515C-8E Basic Programming Mode Selection

The basic programming mode selection scheme is shown in figure 27.


Figure 27
C515C-8E Basic Programming Mode Selection

Table 12
Access Modes Selection

| Access Mode | $\begin{aligned} & \overline{\mathrm{EA}} / \\ & \mathbf{V}_{\mathrm{PP}} \end{aligned}$ | $\overline{\text { PROG }}$ | $\overline{\text { PRD }}$ | PMSEL |  | Address <br> (Port 2) | $\begin{gathered} \text { Data } \\ \text { (Port 0) } \end{gathered}$ |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | 1 | 0 |  |  |
| Program OTP memory byte | $V_{\text {PP }}$ | L | H | H | H | $\begin{gathered} \text { A0-7 } \\ \text { A8-15 } \end{gathered}$ | D0-7 |
| Read OTP memory byte | $\mathrm{V}_{1 \mathrm{H}}$ | H | ■ |  |  |  |  |
| Program OTP lock bits | $\mathrm{V}_{\text {PP }}$ | L | H | H | L | - | $\begin{gathered} \text { D1,D0 see } \\ \text { table } \mathbf{1 3} \end{gathered}$ |
| Read OTP lock bits | $\mathrm{V}_{1 \mathrm{H}}$ | H | $\square$ |  |  |  |  |
| Read OTP version byte | $\mathrm{V}_{\mathrm{IH}}$ | H | ■ | L | H | Byte addr. of version byte | D0-7 |

## C515C-8E Lock Bits Programming / Read

The C515C-8E has two programmable lock bits which, when programmed according tabie 13, provide four levels of protection for the on-chip OTP code memory. The state of the lock bits can also be read.

## Table 13

Lock Bit Protection Types

| Lock Bits at D1,D0 |  | Protection |  |
| :--- | :--- | :--- | :--- |
| Level | Protection Type |  |  |
| D1 | D0 | Level 0 | The OTP lock feature is disabled. During normal operation of <br> the C515C-8E, the state of the EA pin is not latched on reset. |
| 1 | 1 | 0 | Level 1 |
| 1 | During normal operation of the C515C-8E, MOVC instructions <br> executed from external program memory are disabled from <br> fetching code bytes from internal memory. EA is sampled and <br> latched on reset. An OTP memory read operation is only <br> possible according to ROM verification mode 2, as it is defined <br> for a protected ROM version of the C515C-8R. Further <br> programming of the OTP memory is disabled (reprogramming <br> security). |  |  |
| 0 | 1 | Level 2 | Same as level 1, but also OTP memory read operation using <br> ROM verification mode 2 is disabled. |
| 0 | 0 | Level 3 | Same as level 2; but additionally external code execution by <br> setting EA =low during normal operation of the C515C-8E is no <br> more possible. <br> External code execution, which is initiated by an internal <br> program (e.g. by an internal jump instruction above the ROM <br> boundary), is still possible. |

## Absolute Maximum Ratings

| Ambient temperature under bias ( $T_{\text {A }}$ ) . | - |
| :---: | :---: |
| Storage temperature ( $T_{\text {stg }}$ ) | $-65^{\circ} \mathrm{C}$ to $150^{\circ} \mathrm{C}$ |
| Voltage on $V_{\mathrm{DD}}$ pins with respect to ground ( $V_{\mathrm{SS}}$ ) | -0.5 V to 6.5 V |
| Voltage on any pin with respect to ground ( $V_{\text {SS }}$ ) | -0.5 V to $V_{\mathrm{DD}}+0.5 \mathrm{~V}$ |
| Input current on any pin during overload condition. | - 10 mA to 10 mA |
| Absolute sum of all input currents during overload condition | 1100 mA I |
| Power dissipation. | TBD |

Note: Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage of the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for longer periods may affect device reliability.
During absolute maximum rating overload conditions ( $V_{I N}>V_{D D}$ or $V_{I N}<V_{S S}$ ) the voltage on $V_{\mathrm{DD}}$ pins with respect to ground ( $V_{S S}$ ) must not exceed the values defined by the absolute maximum ratings.

DC Characteristics

| $V_{\mathrm{DD}}=5 \mathrm{~V}+10 \%,-15 \% ; V_{\mathrm{SS}}=0 \mathrm{~V}$ | $T_{\mathrm{A}}=0$ to $70^{\circ} \mathrm{C}$ |
| :--- | :--- |
|  | $T_{\mathrm{A}}=-40$ to $85^{\circ} \mathrm{C}$ |
|  | $T_{\mathrm{A}}=-40$ to $110^{\circ} \mathrm{C}$ |

for the SAB-C515C
$T_{\mathrm{A}}=-40$ to $85^{\circ} \mathrm{C}$
for the SAF-C515C
for the SAH-C515C

| Parameter | Symbol | Limit Values |  | Unit | Test Condition |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | min. | max. |  |  |
| Input low voltages <br> all except $\overline{\mathrm{EA}}, \overline{\mathrm{RESET}}, \overline{\mathrm{HWPD}}$ <br> EA pin <br> RESET and HWPD pins <br> Port 5 in CMOS mode | $\begin{aligned} & V_{\mathrm{IL}} \\ & V_{\mathrm{LL} 1} \\ & V_{\mathrm{IL} 2} \\ & V_{\mathrm{ILC}} \end{aligned}$ | $\begin{aligned} & -0.5 \\ & -0.5 \\ & -0.5 \\ & -0.5 \end{aligned}$ | $\begin{aligned} & 0.2 V_{\mathrm{DD}}-0.1 \\ & 0.2 V_{\mathrm{DD}}-0.3 \\ & 0.2 V_{\mathrm{DD}}+0.1 \\ & 0.3 V_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \end{aligned}$ | $\begin{aligned} & - \\ & - \\ & - \end{aligned}$ |
| Input high voltages <br> all except XTAL2, $\overline{R E S E T}$, and HWPD) <br> XTAL2 pin <br> RESET and HWPD pins <br> Port 5 in CMOS mode | $\begin{aligned} & V_{\mathrm{IH}} \\ & V_{\mathrm{HH} 1} \\ & V_{\mathrm{HH} 2} \\ & V_{\mathrm{IHC}} \end{aligned}$ | $\begin{aligned} & 0.2 V_{\mathrm{DD}}+0.9 \\ & 0.7 V_{\mathrm{DD}} \\ & 0.6 V_{\mathrm{DD}} \\ & 0.7 V_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & V_{\mathrm{DD}}+0.5 \\ & V_{\mathrm{DD}}+0.5 \\ & V_{\mathrm{DD}}+0.5 \\ & V_{\mathrm{DD}}+0.5 \end{aligned}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \end{aligned}$ | $\begin{aligned} & - \\ & - \\ & - \end{aligned}$ |
| Output low voltages <br> Ports 1, 2, 3, 4, 5, 7 (incl. CMOS) <br> Port 0, ALE, $\overline{\text { PSEN, }}$, $\overline{\text { PPUR }}$ <br> P4.1, P4.3 in push-pull mode | $V_{\text {OL }}$ <br> $V_{\text {OL1 }}$ <br> $V_{\text {OL3 }}$ | - | $\begin{aligned} & 0.45 \\ & 0.45 \\ & 0.45 \end{aligned}$ | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{~V} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{OL}}=1.6 \mathrm{~mA}^{11} \\ & I_{\mathrm{OL}}=3.2 \mathrm{~mA}^{1)} \\ & I_{\mathrm{OL}}=3.75 \mathrm{~mA}^{1)} \end{aligned}$ |
| Output high voltages <br> Ports 1, 2, 3, 4, 5, 7 <br> Port 0 in external bus mode, <br> ALE, $\overline{\text { PSEN, }} \overline{\text { CPUR }}$ <br> Port 5 in CMOS mode <br> P4.1, P4.3 in push-pull mode | $\begin{aligned} & V_{\mathrm{OH}} \\ & V_{\mathrm{OH} 2} \\ & V_{\mathrm{OHC}} \\ & V_{\mathrm{OH} 3} \end{aligned}$ | $\begin{aligned} & 2.4 \\ & 0.9 V_{\mathrm{DD}} \\ & 2.4 \\ & 0.9 V_{\mathrm{DD}} \\ & 0.9 V_{\mathrm{DD}} \\ & 0.9 V_{\mathrm{DD}} \end{aligned}$ | - - - - | $\begin{aligned} & \mathrm{V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \\ & \mathrm{~V} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{OH}}=-80 \mu \mathrm{~A} \\ & I_{\mathrm{OH}}=-10 \mu \mathrm{~A} \\ & I_{\mathrm{OH}}=-800 \mu \mathrm{~A} \\ & I_{\mathrm{OH}}=-80 \mu \mathrm{~A}^{2)} \\ & I_{\mathrm{OH}}=-800 \mu \mathrm{~A} \\ & I_{\mathrm{OH}}=-833 \mu \mathrm{~A} \end{aligned}$ |
| Logic 0 input current Ports 1, 2, 3, 4, 5, 7 | $I_{\text {IL }}$ | -10 | -70 | $\mu \mathrm{A}$ | $V_{\text {IN }}=0.45 \mathrm{~V}$ |
| Logical 0-to-1 transition current Ports 1, 2, 3, 4, 5, 7 | $I_{\text {TL }}$ | -65 | -650 | $\mu \mathrm{A}$ | $V_{\text {IN }}=2 \mathrm{~V}$ |
| Input leakage current Port 0, EA, P6, HWPD, AIN0-7 | $I_{\text {LI }}$ | - | $\pm 1$ | $\mu \mathrm{A}$ | $0.45<V_{\text {IN }}<V_{\text {DD }}$ |
| Input low current <br> To $\overline{\text { RESET }}$ for reset <br> XTAL2 <br> PE/SWD | $\begin{aligned} & I_{\mathrm{LL} 2} \\ & I_{\mathrm{LL} 3} \\ & I_{\mathrm{LL} 4} \end{aligned}$ | $\begin{aligned} & - \\ & - \\ & - \end{aligned}$ | $\begin{aligned} & -100 \\ & -15 \\ & -20 \end{aligned}$ | $\begin{aligned} & \mu \mathrm{A} \\ & \mu \mathrm{~A} \\ & \mu \mathrm{~A} \end{aligned}$ | $\begin{aligned} & V_{\text {IN }}=0.45 \mathrm{~V} \\ & V_{\text {IN }}=0.45 \mathrm{~V} \\ & V_{\text {IN }}=0.45 \mathrm{~V} \end{aligned}$ |
| Pin capacitance | $C_{\text {⿺夂 }}$ | - | 10 | pF | $\begin{aligned} & f_{\mathrm{c}}=1 \mathrm{MHz}, \\ & T_{\mathrm{A}}=25^{\circ} \mathrm{C} \end{aligned}$ |
| Overload current | $I_{\text {OV }}$ | - | $\pm 5$ | mA | 8) 9) |
| Programming voltage | $V_{\text {PP }}$ | 10.9 | 12.1 | V | $11.5 \mathrm{~V} 5 \%$ |

## Power Supply Current

| Parameter |  |  | Symbol | Limit Values |  | Unit | Test Condition |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | typ. ${ }^{10}$ | max. ${ }^{11)}$ |  |  |
| Active mode | C515C-8R | $\begin{aligned} & 6 \mathrm{MHz} \\ & 10 \mathrm{MHz} \end{aligned}$ |  | $\begin{aligned} & I_{\mathrm{DD}} \\ & I_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & \hline 12.0 \\ & 18.9 \end{aligned}$ | $\begin{aligned} & 16.1 \\ & 25.5 \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ | 4) |
|  | C515C-8E | $\begin{aligned} & 6 \mathrm{MHz} \\ & 10 \mathrm{MHz} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{DD}} \\ & I_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & \hline \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \hline \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |  |  |
| Idle mode | C515C-8R | $\begin{aligned} & 6 \mathrm{MHz} \\ & 10 \mathrm{MHz} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{DD}} \\ & I_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & 6.9 \\ & 10.5 \end{aligned}$ | $\begin{aligned} & 9.8 \\ & 15 \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ | 5) |  |
|  | C515C-8E | $\begin{aligned} & 6 \mathrm{MHz} \\ & 10 \mathrm{MHz} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{DD}} \\ & I_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |  |  |
| Active mode with slow-down enabled | C515C-8R | $\begin{aligned} & 6 \mathrm{MHz} \\ & 10 \mathrm{MHz} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{DD}} \\ & I_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ | 6) |  |
|  | C515C-8E | $\begin{aligned} & 6 \mathrm{MHz} \\ & 10 \mathrm{MHz} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{DD}} \\ & I_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |  |  |
| Idle mode with slow-down enabled | C515C-8R | $\begin{aligned} & 6 \mathrm{MHz} \\ & 10 \mathrm{MHz} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{DD}} \\ & I_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ | ${ }^{7}$ |  |
|  | C515C-8E | $\begin{aligned} & 6 \mathrm{MHz} \\ & 10 \mathrm{MHz} \end{aligned}$ | $\begin{aligned} & I_{\mathrm{DD}} \\ & I_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ | $\begin{aligned} & \mathrm{mA} \\ & \mathrm{~mA} \end{aligned}$ |  |  |
| Power-down mode | C515C-8R |  | $I_{\text {PD }}$ | TBD | 50 | $\mu \mathrm{A}$ | $V_{\mathrm{CC}}=2 \ldots 5.5 \mathrm{~V}^{3}$ |  |
|  | C515C-8E |  | $I_{\text {PD }}$ | TBD | TBD | $\mu \mathrm{A}$ |  |  |
| At $\overline{\mathrm{EA}} / \mathrm{V}_{\mathrm{PP}}$ in programming mode | C515C-8E |  | $I_{\text {DDP }}$ | - | 30 | mA |  |  |

## Notes:

1) Capacitive loading on ports 0 and 2 may cause spurious noise pulses to be superimposed on the $V_{\text {OL }}$ of ALE and port 3 . The noise is due to external bus capacitance discharging into the port 0 and port 2 pins when these pins make 1-to-0 transitions during bus operation. In the worst case (capacitive loading > 100 pF ), the noise pulse on ALE line may exceed 0.8 V . In such cases it may be desirable to qualify ALE with a schmitt-trigger, or use an address latch with a schmitt-trigger strobe input.
2) Capacitive loading on ports 0 and 2 may cause the $V_{\text {OH }}$ on ALE and $\overline{\text { PSEN }}$ to momentarily fall below the $0.9 V_{\mathrm{DD}}$ specification when the address lines are stabilizing.
3) $I_{\mathrm{PD}}$ (power-down mode) is measured under following conditions:
$\overline{\mathrm{EA}}=\overline{\mathrm{RESET}}=$ Port $0=$ Port $6=V_{\mathrm{DD}} ; \mathrm{XTAL1}=\mathrm{N} . \mathrm{C} . ; \mathrm{XTAL2}=V_{\mathrm{SS}} ; \overline{\mathrm{PE}} / \mathrm{SWD}=V_{\mathrm{SS}} ; \overline{\mathrm{HWPD}}=V_{\mathrm{DD}} ;$ $V_{\text {AGND }}=V_{\mathrm{SS}} ; V_{\text {AREF }}=V_{\mathrm{DD}} ;$ all other pins are disconnected.
$I_{\mathrm{PD}}$ (hardware power-down mode) is independent of any particular pin connection.
4) $I_{\mathrm{DD}}$ (active mode) is measured with:

XTAL2 driven with $t_{\mathrm{CLCH}}, t_{\mathrm{CHCL}}=5 \mathrm{~ns}, V_{\mathrm{IL}}=V_{\mathrm{SS}}+0.5 \mathrm{~V}, V_{\mathrm{IH}}=V_{\mathrm{DD}}-0.5 \mathrm{~V} ;$ XTAL1 $=\mathrm{N} . \mathrm{C}$. ;
$\overline{\mathrm{EA}}=\overline{\mathrm{PE}} / \mathrm{SWD}=\mathrm{Port} 0=\mathrm{Port} 6=V_{\mathrm{DD}} ; \mathrm{HWPD}=V_{\mathrm{DD}} ; \mathrm{RESET}=V_{\mathrm{SS}} ;$ all other pins are disconnected.
5) $I_{\mathrm{DD}}$ (idle mode) is measured with all output pins disconnected and with all peripherals disabled;

XTAL2 driven with $t_{\mathrm{CLCH}}, t_{\mathrm{CHCL}}=5 \mathrm{~ns}, V_{\mathrm{IL}}=V_{\mathrm{SS}}+0.5 \mathrm{~V}, V_{\mathrm{IH}}=V_{\mathrm{DD}}-0.5 \mathrm{~V} ;$ XTAL1 $=$ N.C.;
$\overline{\mathrm{RESET}}=V_{\mathrm{DD}} ; \mathrm{EA}=V_{\mathrm{SS}} ;$ Port0 $=V_{\mathrm{DD}} ;$ all other pins are disconnected;
6) $I_{\mathrm{DD}}$ (active mode with slow-down mode) is measured with : TBD
7) $I_{\mathrm{DD}}$ (idle mode with slow-down mode) is measured with : TBD
8) Overload conditions under operating conditions occur if the voltage on the respective pin exceeds the specified operating range (ie. $V_{\mathrm{OV}}>V_{\mathrm{DD}}+0.5 \mathrm{~V}$ or $V_{\mathrm{OV}}<V_{\mathrm{SS}}-0.5 \mathrm{~V}$ ). The absolute sum of input overload currents on all port pins may not exceed 50 mA . The supply voltage ( $V_{D D}$ and $V_{S S}$ ) must remain within the specified limits.
9) Not $100 \%$ tested, guaranteed by design characterization
10)The typical $I_{\mathrm{DD}}$ values are periodically measured at $T_{\mathrm{A}}=+25{ }^{\circ} \mathrm{C}$ and $V_{\mathrm{DD}}=5 \mathrm{~V}$ but not $100 \%$ tested.
11)The maximum $I_{\mathrm{DD}}$ values are measured under worst case conditions ( $T_{\mathrm{A}}=0{ }^{\circ} \mathrm{C}$ or $-40^{\circ} \mathrm{C}$ and $V_{\mathrm{DD}}=5.5 \mathrm{~V}$ )

Power Supply Current Calculation Formulas

| Parameter |  | Symbol | Formula |
| :---: | :---: | :---: | :---: |
| Active mode | C515C-8R | $I_{\mathrm{DD} \text { typ }}$ <br> $I_{\mathrm{DD} \text { max }}$ | $\begin{aligned} & 1.72 * f_{\text {osc }}+1.72 \\ & 2.33 * f_{\text {osc }}+2.15 \end{aligned}$ |
|  | C515C-8E | $I_{\mathrm{DD} \mathrm{typ}}$ <br> $I_{\mathrm{DD} \text { max }}$ | $\begin{array}{\|l\|} \text { TBD } \\ \text { TBD } \end{array}$ |
| Idle mode | C515C-8R | $I_{\text {DD typ }}$ <br> $I_{\mathrm{DD} \text { max }}$ | $\begin{aligned} & 0.9 * f_{\text {osc }}+1.5 \\ & 1.3 * f_{\text {OsC }}+2.0 \end{aligned}$ |
|  | C515C-8E | $I_{\mathrm{DD} \mathrm{typ}}$ $I_{\mathrm{DD} \text { max }}$ | $\begin{aligned} & \hline \text { TBD } \\ & \text { TBD } \end{aligned}$ |
| Active mode with slow-down enabled | C515C-8R | $I_{\mathrm{DD} \text { typ }}$ <br> $I_{\mathrm{DD} \text { max }}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ |
|  | C515C-8E | $I_{\text {DD typ }}$ <br> $I_{\mathrm{DD} \text { max }}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ |
| Idle mode with slow-down enabled | C515C-8R | $I_{\text {DD typ }}$ <br> $I_{\mathrm{DD} \text { max }}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ |
|  | C515C-8E | $I_{\mathrm{DD} \text { typ }}$ <br> $I_{\mathrm{DD} \text { max }}$ | $\begin{aligned} & \text { TBD } \\ & \text { TBD } \end{aligned}$ |

Note : $f_{\text {osc }}$ is the oscillator frequency in MHz . $I_{\mathrm{DD}}$ values are given in mA .

## C515C-8R



The IDD diagram for the C515C-8E is to be defined.

## A/D Converter Characteristics

$V_{\mathrm{DD}}=5 \mathrm{~V}+10 \%,-15 \% ; V_{\mathrm{SS}}=0 \mathrm{~V}$

$$
\begin{array}{ll}
T_{\mathrm{A}}=0 \text { to } 70^{\circ} \mathrm{C} & \text { for the SAB-C515C } \\
T_{\mathrm{A}}=-40 \text { to } 85^{\circ} \mathrm{C} & \text { for the SAF-C515C } \\
T_{\mathrm{A}}=-40 \text { to } 110^{\circ} \mathrm{C} & \text { for the SAH-C515C }
\end{array}
$$

$4 \mathrm{~V} \leq V_{\text {AREF }} \leq V_{\mathrm{DD}}+0.1 \mathrm{~V} ; V_{\mathrm{SS}}-0.1 \mathrm{~V} \leq V_{\mathrm{AGND}} \leq V_{\mathrm{SS}}+0.2 \mathrm{~V}$

| Parameter | Symbol | Limit Values |  | Unit | Test Condition |
| :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | min. | max. |  |  |
| Analog input voltage | $V_{\text {AIN }}$ | $V_{\text {AGND }}$ | $V_{\text {AREF }}$ | V | 1) |
| Sample time | $t_{\text {s }}$ | - | $\begin{aligned} & 16 \times t_{\mathbb{N}} \\ & 8 \times t_{\mathbb{N}} \end{aligned}$ | ns | $\begin{array}{ll} \text { Prescaler } \div 8 & \\ \text { Prescaler } \div 4 & \text { 2) } \end{array}$ |
| Conversion cycle time | $t_{\text {ADCC }}$ | - | $\begin{aligned} & 96 \times t_{\mathrm{IN}} \\ & 48 \times t_{\mathrm{IN}} \end{aligned}$ | ns | $\begin{aligned} & \text { Prescaler } \div 8 \\ & \text { Prescaler } \div 4 \end{aligned}$ |
| Total unadjusted error | $T_{\text {UE }}$ | - | $\pm 2$ | LSB | 4) |
| Internal resistance of reference voltage source | $R_{\text {AREF }}$ | - | $\begin{aligned} & t_{\mathrm{ADC}} / 250 \\ & -0.25 \end{aligned}$ | $\mathrm{k} \Omega$ | $t_{\text {ADC }} \mathrm{in}[\mathrm{ns}]^{5) 6}$ |
| Internal resistance of analog source | $R_{\text {ASRC }}$ | - | $\begin{aligned} & t_{\mathrm{s}} / 500 \\ & -0.25 \end{aligned}$ | k $\Omega$ | $t_{\mathrm{S}} \mathrm{in}[\mathrm{ns}]^{2)}{ }^{\text {6) }}$ |
| ADC input capacitance | $C_{\text {AIN }}$ | - | 50 | pF | 6) |

Notes see next page.
Clock calculation table:

| Clock Prescaler <br> Ratio | ADCL | $\mathbf{t}_{\text {ADC }}$ | $\mathbf{t}_{\mathbf{S}}$ | $\mathbf{t}_{\text {ADCC }}$ |
| :--- | :--- | :--- | :--- | :--- |
| $\div 8$ | 1 | $8 \times \mathrm{t}_{\mathrm{N}}$ | $16 \times \mathrm{t}_{\mathrm{N}}$ | $96 \times \mathrm{t}_{\mathrm{IN}}$ |
| $\div 4$ | 0 | $4 \times \mathrm{t}_{\mathrm{IN}}$ | $8 \times \mathrm{t}_{\mathrm{IN}}$ | $48 \times \mathrm{t}_{\mathrm{IN}}$ |

Further timing conditions: $\mathrm{t}_{\mathrm{ADC}} \mathrm{min}=500 \mathrm{~ns}$

$$
\mathrm{t}_{\mathrm{IN}}=1 / \mathrm{f} \mathrm{OSC}=\mathrm{t}_{\mathrm{CLP}}
$$

## Notes:

1) $V_{\text {AIN }}$ may exeed $V_{\text {AGND }}$ or $V_{\text {AREF }}$ up to the absolute maximum ratings. However, the conversion result in these cases will be $\mathrm{X} 000_{\mathrm{H}}$ or $\mathrm{X}^{2} \mathrm{FF}_{\mathrm{H}}$, respectively.
2) During the sample time the input capacitance CAIN can be charged/discharged by the external source. The internal resistance of the analog source must allow the capacitance to reach their final voltage level within ts. After the end of the sample time ts, changes of the analog input voltage have no effect on the conversion result.
3) This parameter includes the sample time $t_{S}$, the time for determining the digital result and the time for the calibration. Values for the conversion clock $\mathrm{t}_{\text {ADC }}$ depend on programming and can be taken from the table on the previous page.
4) $\mathrm{T}_{\mathrm{UE}}$ is tested at $\mathrm{V}_{\mathrm{AREF}}=5.0 \mathrm{~V}, \mathrm{~V}_{\mathrm{AGND}}=0 \mathrm{~V}, \mathrm{~V}_{\mathrm{DD}}=4.9 \mathrm{~V}$. It is guaranteed by design characterization for all other voltages within the defined voltage range.
If an overload condition occurs on maximum 2 not selected analog input pins and the absolute sum of input overload currents on all analog input pins does not exceed 10 mA , an additional conversion error of 1/2 LSB is permissible.
5) During the conversion the ADC's capacitance must be repeatedly charged or discharged. The internal resistance of the reference source must allow the capacitance to reach their final voltage level within the indicated time. The maximum internal resistance results from the programmed conversion timing.
6) Not $100 \%$ tested, but guaranteed by design characterization.

## AC Characteristics

| $V_{\mathrm{DD}}=5 \mathrm{~V}+10 \%,-15 \% ; V_{\mathrm{SS}}=0 \mathrm{~V}$ | $T_{\mathrm{A}}=0$ to $70^{\circ} \mathrm{C}$ | for the SAB-C515C |
| :--- | :--- | :--- |
|  | $T_{\mathrm{A}}=-40$ to $85^{\circ} \mathrm{C}$ | for the SAF-C515C |
| $T_{\mathrm{A}}=-40$ to $110^{\circ} \mathrm{C}$ | for the SAH-C515C |  |

( $C_{\mathrm{L}}$ for port 0, ALE and $\overline{\text { PSEN }}$ outputs $=100 \mathrm{pF} ; C_{\mathrm{L}}$ for all other outputs $=80 \mathrm{pF}$ )

## Program Memory Characteristics

| Parameter | Symbol | Limit Values |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | 10-MHz clock Duty Cycle 0.4 to 0.6 |  | Variable Clock 1/CLP = 2 MHz to 10 MHz |  |  |
|  |  | min. | max. | min. | max. |  |
| ALE pulse width | $t_{\text {LHLL }}$ | 60 | - | CLP - 40 | - | ns |
| Address setup to ALE | $t_{\text {AVLL }}$ | 15 | - | TCL ${ }_{\text {Hmin }}-25$ | - | ns |
| Address hold after ALE | $t_{\text {LLAX }}$ | 15 | - | TCL ${ }_{\text {Hmin }}-25$ | - | ns |
| ALE to valid instruction in | $t_{\text {LIIV }}$ | - | 113 | - | 2 CLP - 87 | ns |
| ALE to PSEN | $t_{\text {LLPL }}$ | 20 | - | TCL ${ }_{\text {Lmin }}-20$ | - | ns |
| $\overline{\text { PSEN }}$ pulse width | $t_{\text {PLPH }}$ | 115 | - | $\begin{aligned} & \text { CLP+ } \\ & \text { TCL }_{\text {Hin }}-30 \\ & \hline \end{aligned}$ | - | ns |
| $\overline{\text { PSEN }}$ to valid instruction in | $t_{\text {PLIV }}$ | - | 75 | - | $\begin{aligned} & \text { CLP+ } \\ & \text { TCL }_{\text {Hmin }}-65 \end{aligned}$ | ns |
| Input instruction hold after $\overline{\text { PSEN }}$ | $t_{\text {PXIX }}$ | 0 | - | 0 | - | ns |
| Input instruction float after $\overline{\text { PSEN }}$ | $t_{\text {PXIZ }}{ }^{*}$ ) | - | 30 | - | TCL ${ }_{\text {Lmin }}-10$ | ns |
| Address valid after PSEN | $t_{\text {PXAV }}{ }^{\text {\% }}$ | 35 | - | TCL ${ }_{\text {Lmin }}-5$ | - | ns |
| Address to valid instruction in | $t_{\text {AVIV }}$ | - | 180 | - | $\begin{aligned} & 2 \text { CLP + } \\ & \text { TCL }_{H \text { min }}-60 \end{aligned}$ | ns |
| Address float to PSEN | $t_{\text {AZPL }}$ | 0 |  | 0 | - | ns |

*) Interfacing the C515C to devices with float times up to 35 ns is permissible. This limited bus contention will not cause any damage to port 0 drivers.

## External Data Memory Characteristics

| Parameter | Symbol | Limit Values |  |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | $\begin{gathered} 10-\mathrm{MHz} \\ \text { clock } \\ \text { Duty Cycle } \\ 0.4 \text { to } 0.6 \end{gathered}$ |  | Variable Clock 1/CLP= 2 MHz to 10 MHz |  |  |
|  |  | min. | max. | min. | max. |  |
| $\overline{\mathrm{RD}}$ pulse width | $t_{\text {RLRH }}$ | 230 | - | 3 CLP - 70 | - | ns |
| WR pulse width | $t_{\text {WLWH }}$ | 230 | - | 3 CLP - 70 | - | ns |
| Address hold after ALE | $t_{\text {LLAX2 }}$ | 48 | - | CLP - 15 | - | ns |
| $\overline{\mathrm{RD}}$ to valid data in | $t_{\text {RLDV }}$ | - | 150 | - | $\begin{aligned} & 2 \text { CLP }_{+} \\ & \text {TCL }_{\text {Hmin }}-90 \end{aligned}$ | ns |
| Data hold after $\overline{\mathrm{RD}}$ | $t_{\text {RHDX }}$ | 0 |  | 0 | - | ns |
| Data float after $\overline{\mathrm{RD}}$ | $t_{\text {RHDZ }}$ | - | 80 | - | CLP - 20 | ns |
| ALE to valid data in | $t_{\text {LLDV }}$ | - | 267 | - | 4 CLP - 133 | ns |
| Address to valid data in | $t_{\text {AVDV }}$ | - | 285 | - | $\begin{aligned} & 4 C L P+ \\ & \text { TCL }_{\text {Hin }}-155 \end{aligned}$ | ns |
| ALE to $\overline{\mathrm{WR}}$ or $\overline{\mathrm{RD}}$ | $t_{\text {LLWL }}$ | 90 | 190 | $\begin{aligned} & \text { CLP }+ \\ & \text { TCL }_{\text {Lmin }}-50 \end{aligned}$ | $\begin{array}{\|l\|l} \hline \text { CLP }_{+} \\ \text {TCL }_{\text {Lmin }}+50 \\ \hline \end{array}$ | ns |
| Address valid to $\overline{\mathrm{WR}}$ | $t_{\text {AVWL }}$ | 103 | - | 2 CLP - 97 | - | ns |
| $\overline{\overline{W R}}$ or $\overline{\mathrm{RD}}$ high to ALE high | $t_{\text {WHLH }}$ | 15 | 65 | TCL ${ }_{\text {Hmin }}-25$ | TCL ${ }_{\text {Hmin }}+25$ | ns |
| Data valid to $\overline{W R}$ transition | $t_{\text {Qvwx }}$ | 5 | - | TCL $L_{\text {min }}-35$ | - | ns |
| Data setup before $\overline{\mathrm{WR}}$ | $t_{\text {Qvwh }}$ | 218 | - | $\begin{aligned} & 3 C L P P_{+} \\ & \text {TCL }_{L \text { min }}-122 \end{aligned}$ | - | ns |
| Data hold after $\overline{\mathrm{WR}}$ | $t_{\text {Whax }}$ | 13 | - | $\mathrm{TCL}_{\text {Hmin }}-27$ | - | ns |
| Address float after $\overline{\mathrm{RD}}$ | $t_{\text {RLAZ }}$ | - | 0 | - | 0 | ns |

## SSC Interface Characteristics

| Parameter | Symbol | Limit Values |  | Unit |
| :---: | :---: | :---: | :---: | :---: |
|  |  | min. | max. |  |
| Clock Cycle Time : Master Mode Slave Mode | $t_{\text {SCLK }}$ $t_{\text {SCLK }}$ | $\begin{aligned} & 0.4 \\ & 1.0 \end{aligned}$ | $-$ | $\mu \mathrm{s}$ <br> $\mu \mathrm{S}$ |
| Clock high time | $t_{\text {SCH }}$ | 360 | - | ns |
| Clock low time | $t_{\text {ScL }}$ | 360 | - | ns |
| Data output delay | $t_{\mathrm{D}}$ | - | 100 | ns |
| Data output hold | $t_{\text {Ho }}$ | 0 | - | ns |
| Data input setup | $t_{\mathrm{s}}$ | 100 | - | ns |
| Data input hold | $t_{\text {HII }}$ | 100 | - | ns |
| TC bit set delay | $t_{\text {DTC }}$ | - | 8 CLP | ns |

## External Clock Drive at XTAL2

| Parameter | Symbol | CPU Clock $=10 \mathrm{MHz}$ <br> Duty cycle 0.4 to 0.6 |  | Variable CPU Clock 1/CLP = 2 to 10 MHz |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | min. | max. | min. | max. |  |
| Oscillator period | CLP | 100 | 100 | 100 | 500 | ns |
| High time | $\mathrm{TCL}_{\text {H }}$ | 40 | - | 40 | CLP-TCL ${ }_{\text {L }}$ | ns |
| Low time | $\mathrm{TCL}_{\mathrm{L}}$ | 40 | - | 40 | CLP-TCL ${ }_{\text {H }}$ | ns |
| Rise time | $t_{\text {R }}$ | - | 12 | - | 12 | ns |
| Fall time | $t_{\mathrm{F}}$ | - | 12 | - | 12 | ns |
| Oscillator duty cycle | DC | 0.4 | 0.6 | 40 / CLP | 1-40 / CLP | - |
| Clock cycle | TCL | 40 | 60 | CLP * $\mathrm{DC}_{\text {min }}$ | CLP * DC ${ }_{\text {max }}$ | ns |

Note: The 10 MHz values in the tables are given as an example for a typical duty cycle variation of the oscillator clock from 0.4 to 0.6 .
$\qquad$


Figure 29

## Program Memory Read Cycle



Figure 30
Data Memory Read Cycle
$\qquad$


Figure 31

## Data Memory Write Cycle



Figure 32

## External Clock Drive at XTAL2

$\qquad$


Notes: Shown is the data/clock relationship for CPOL=CPHA $=1$. The timing diagram is valid for the other cases accordingly.

In the case of slave mode and CPHA=0, the output delay for the MSB applies to the falling edge of $\overline{S L S}$ (if transmitter is enabled).

In the case of master mode and CPHA=0, the MSB becomes valid after the data has been written into the shift register, i.e. at least one half SCLK clock cycle before the first clock transition.

Figure 33

## SSC Timing

## OTP Memory Programming Mode Characteristics

$V_{\mathrm{DD}}=5 \mathrm{~V} 10 \% ; V_{\mathrm{PP}}=11.5 \mathrm{~V} 5 \% ; T_{\mathrm{A}}=25^{\circ} \mathrm{C} 10^{\circ} \mathrm{C}$

| Parameter | Symbol | Limit Values |  | Unit |
| :---: | :---: | :---: | :---: | :---: |
|  |  | min. | max. |  |
| ALE pulse width | $t_{\text {PAW }}$ | 35 | - | ns |
| PMSEL setup to ALE rising edge | $t_{\text {PMS }}$ | 10 | - | ns |
| Address setup to ALE, $\overline{\text { PROG }}$, or $\overline{\text { PRD falling }}$ edge | $t_{\text {Pas }}$ | 10 | - | ns |
| Address hold after ALE, $\overline{\text { PROG }}$, or $\overline{\text { PRD }}$ falling edge | $t_{\text {PAH }}$ | 10 | - | ns |
| Address, data setup to PROG or $\overline{\text { PRD }}$ | $t_{\text {PCS }}$ | 100 | - | ns |
| Address, data hold after $\overline{\text { PROG }}$ or $\overline{\text { PRD }}$ | $t_{\text {PCH }}$ | 0 | - | ns |
| PMSEL setup to $\overline{\text { PROG }}$ or $\overline{\text { PRD }}$ | $t_{\text {PMS }}$ | 10 | - | ns |
| PMSEL hold after $\overline{\text { PROG }}$ or $\overline{\text { PRD }}$ | $t_{\text {PMH }}$ | 10 | - | ns |
| PROG pulse width | $t_{\text {PWw }}$ | 100 | - | $\mu \mathrm{s}$ |
| $\overline{\text { PRD pulse width }}$ | $t_{\text {PRW }}$ | 100 | - | ns |
| Address to valid data out | $t_{\text {PAD }}$ | - | 75 | ns |
| $\overline{\text { PRD }}$ to valid data out | $t_{\text {PRD }}$ | - | 20 | ns |
| Data hold after PRD | $t_{\text {PDH }}$ | 0 | - | ns |
| Data float after $\overline{\text { PRD }}$ | $t_{\text {PDF }}$ | - | 20 | ns |
| $\overline{\text { PROG }}$ high between two consecutive $\overline{\text { PROG }}$ low pulses | $t_{\text {PWH1 }}$ | 1 | - | $\mu \mathrm{S}$ |
| $\overline{\text { PRD }}$ high between two consecutive $\overline{\text { PRD low }}$ pulses | $t_{\text {PWH2 }}$ | 100 |  | ns |
| XTAL clock period | $t_{\text {CLKP }}$ | 2 | 10 | MHz |



Figure 34
Programming Code Byte - Write Cycle Timing
$\qquad$


Notes: PROG must be high during a programming read cycle.
МСТ03689

Figure 35
Verify Code Byte - Read Cycle Timing


Note: PALE should be low during a lock bit read / write cycle.
MCT03393

Figure 36
Lock Bit Access Timing


Note: PROG must be high during a programming read cycle. МСТ03394

Figure 37 Version Byte - Read Timing

ROM/OTP Verification Characteristics for C515C-8R / C515C-8E
ROM Verification Mode 1 (C515C-8R)

| Parameter | Symbol | Limit Values |  | Unit |
| :--- | :--- | :--- | :--- | :--- |
|  |  | min. | max. |  |
| Address to valid data | $t_{\text {AvQv }}$ | - | 5 CLP | ns |



Figure 38
ROM Verification Mode 1

ROM/OTP Verification Mode 2

| Parameter | Symbol | Limit Values |  |  | Unit |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- |
|  |  | min. | typ | max. |  |
| ALE pulse width | $t_{\mathrm{AWD}}$ | - | CLP | - | ns |
| ALE period | $t_{\mathrm{ACY}}$ | - | 6 CLP | - | ns |
| Data valid after ALE | $t_{\mathrm{DVA}}$ | - | - | 2 CLP | ns |
| Data stable after ALE | $t_{\mathrm{DSA}}$ | 4 CLP | - | - | ns |
| P3.5 setup to ALE low | $t_{\mathrm{AS}}$ | - | $t_{\mathrm{CL}}$ | - | ns |
| Oscillator frequency | $1 / \mathrm{CLP}$ | 4 | - | 6 | MHz |



Figure 39
ROM/OTP Verification Mode 2


AC Inputs during testing are driven at $V_{\mathrm{DD}}-0.5 \mathrm{~V}$ for a logic ' 1 ' and 0.45 V for a logic ' 0 '. Timing measurements are made at $V_{\text {IHmin }}$ for a logic ' 1 ' and $V_{\text {ILmax }}$ for a logic '0'.

Figure 40
AC Testing: Input, Output Waveforms


MCT00038
For timing purposes a port pin is no longer floating when a 100 mV change from load voltage occurs and begins to float when a 100 mV change from the loaded $V_{\text {OH }} / V_{\text {OL }}$ level occurs.
$I_{\mathrm{OL}} / I_{\mathrm{OH}} \geq \pm 20 \mathrm{~mA}$
Figure 41
AC Testing: Float Waveforms

| Crystal/Resonator Oscillator Mode |  | Driving from External Source |  |
| :---: | :---: | :---: | :---: |
|  | XTAL1 | N.C. | XTAL1 |
|  | XTAL2 | External Oscillator Signal | XTAL2 |
| Crystal Mode : $\mathrm{C}=20 \mathrm{pF} \pm 10 \mathrm{pF}$ (incl. stray capacitance) |  |  |  |

Figure 42
Recommended Oscillator Circuits for Crystal Oscillator

```
P-MQFP-80-1 (SMD)
(Plastic Metric Quad Flat Package)
```



Figure 43

## Package Outlines

## Sorts of Packing

Package outlines for tubes, trays etc. are contained in our
Data Book "Package Information"


[^0]:    *) $1=$ Input
    $\mathrm{O}=$ Output

[^1]:    *) $1=$ Input
    $\mathrm{O}=$ Output

[^2]:    *) $1=$ Input
    $\mathrm{O}=$ Output

[^3]:    *) 1 = Input
    $\mathrm{O}=$ Output

[^4]:    *) $1=$ Input
    $\mathrm{O}=$ Output

